Objective data sheet

# 1 General description

The NTM88 family consists of small (4 mm x 4 mm x 1.98 mm), fully integrated tire pressure monitoring sensors (TPMS). The devices described in this data sheet, NTM88Hxx5S, provide low transmitting power consumption, large customer memory size, and single- or dual-axis accelerometer architecture. The NTM88Hxx5S TPMS solution integrates an 8-bit microcontroller (MCU), pressure sensor, accelerometers in five ranges, programmable RF transmitter and flexible LF receiver. The sensor supports seven GPIOs, client SPI, and a 2-channel timer / pulse-width module.

#### 2 Features and benefits

- Optional pressure ranges<sup>1</sup>
- Optional accelerometer ranges: See Section 3.
- Transducer measurement interfaces with low-power AFE:
  - 10-bit compensated pressure sense element
  - 10-bit compensated accelerometers
  - 8-bit compensated internal device temperature measurement
  - 8-bit compensated internal device voltage measurement
  - Two I/O pins can be used for external signals
- 8-bit S08 compact instruction set controller:
  - 64 bytes low-power "always on" NVM parameter registers
  - 512 bytes SRAM
  - 16 kB flash memory (512 bytes reserved for NXP coefficients)
  - Family of NXP firmware libraries available via royalty-free license
- Programmable RF transmitter
  - Characterized for RF carrier typical of 315 MHz or 434 MHz
  - Characterized for FSK in ~3 kHz increments or OOK modulation
  - Characterized for baud rate examples of 9.6 kbp/s, 19.2 kbp/s, and 38.4 kbp/s
- Flexible 125 kHz LF receiver:
  - Capability for ASK or OOK demodulation
  - Automated Manchester decoding
- Two channel timer / pulse-width module
- Client SPI to support host access to internal peripherals, registers, and memory
- Seven GPIOs with programmable multiplexing to support software development, external analog voltage input, timer, SPI, and wake-up
- Qualified in compliance with AEC-Q100, Rev. H
- · Long battery service life
- · Internal temperature sensor



<sup>1</sup> Consult NXP sales for details or specific requests.

- · Internal voltage sensor
- Six-channel, 8-, 10-, or 12-bit analog-to-digital converter (ADC10) with two external I/O inputs
- Internal 315-/434-M Hz RF transmitter
  - External crystal oscillator
  - PLL-based output with fractional-n divider
  - OOK and FSK modulation capability
  - Programmable data rate generator
  - Manchester, Bi-Phase, or NRZ data encoding
  - 256-bit RF data buffer variable length interrupt
  - Direct access to RF transmitter from MCU for unique formats
  - Low-power consumption
- · Differential input LF detector/decoder on independent signal pins
- Real-time Interrupt driven by LFO with intervals of 2, 4, 8, 16, 32, 64, or 128 ms
- Free-running counter, low-power, wake up timer and periodic reset driven by LFO
- · Watchdog timeout with selectable times and clock sources
- Two-channel general-purpose timer/PWM module (TPM1)
- · Internal oscillators
  - MCU bus clock of 0.5, 1, 2, and 4 MHz (1, 2, 4, and 8 MHz HFO)
  - Low frequency, low-power time clock (LFO) with 1 ms period
  - Medium frequency, controller clock (MFO) of 8 µs period
- · Low-voltage detection

# 3 Ordering information

Table 1. Ordering information

Type number	Package	ackage								
	Name	Description	Version							
NTM88Hxx5S	HQFN24	Plastic thermal enhanced quad flat package; no leads, 0.1 dimple wettable flank; 24 terminals; 0.5 mm pitch, 4 mm x 4 mm x 1.98 mm body	SOT1931-1(D)							

Table 2. Ordering options

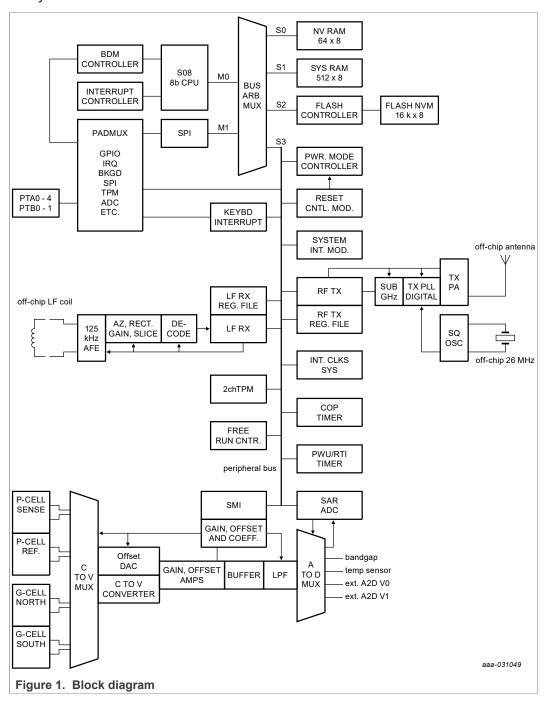
Part Number 'N8'	Pressure Range 'p'	Accelerometer 'aa'		X-axis Range	Z-axis Range	CodeH Hardware (First Rev) <sup>[1]</sup>
NTM88H025ST1 <sup>[2]</sup>		Z	'02'	N/A	-360 g to +400 g	\$A2
NTM88H055ST1 <sup>[2]</sup>			'05'	–80 g to +90 g		\$A5
NTM88H065ST1 <sup>[2]</sup>		X	'06'	-360 g to +400 g	NA	\$A6
NTM88H075ST1 <sup>[2]</sup>	90 kPa to		'07'	–120 g to +520 g		\$A7
NTM88H125ST1 <sup>[2]</sup>	930 kPa 'H'		'12'	-400 g to +400 g	–175 g to +550 g	\$AC
NTM88H135ST1 <sup>[2]</sup>		XZ	'13'	–80 g to +90 g	-360 g to +400 g	\$AD
NTM88H145ST1 <sup>[2]</sup>		\^_	'14'	-360 g to +400 g	–80 g to +90 g	\$AE
NTM88H155ST1 <sup>[2]</sup>			'15'	-360 g to +400 g	-360 g to +400 g	\$AF

NTM88Hxx5S

- [1] The value CodeF mentioned in the User Manual UM11227<sup>[1]</sup> depicts the version of firmware used by NXP during device tests, and will become \$FF as the device is shipped. The value of CodeF will be replaced again by the version number of the firmware library used by the customer at the time of device final application programming.
- [2] Product under development, consult your NXP sales representatives for samples.

# 4 Block diagram

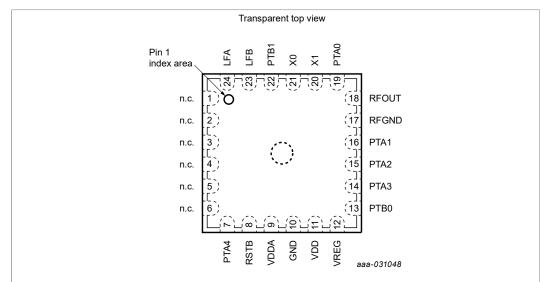
<u>Figure 1</u> presents the device's main blocks and their signal interactions. Power management controls and bus control signals are not shown in this block diagram for clarity.



# 5 Pinning information

### 5.1 Pinning

A top view of the device pint with the pressure port on top is show in <u>Figure 2</u>. The orientation of the internal Z-axis accelerometer is shown in <u>Figure 3</u>.



**Note:** Pins 1-6 are mechanically and electrically connected to the central flag; See <u>Section 9</u>.

Figure 2. Pin configuration

### 5.2 Pin description

Table 3. Pin description

Symbol	Pin	Function	Description
n.c.	1	_	Do not connect electrical signals to this pin; solder joint only.
n.c.	2	_	Do not connect electrical signals to this pin; solder joint only.
n.c.	3	_	Do not connect electrical signals to this pin; solder joint only.
n.c.	4	_	Do not connect electrical signals to this pin; solder joint only.
n.c.	5	_	Do not connect electrical signals to this pin; solder joint only.
n.c.	6	_	Do not connect electrical signals to this pin; solder joint only.
PTA4	7	PTA4 / BKGD	PTA4 Pin - The PTA4 pin places the device in the BACKGROUND DEBUG mode (BDM) to evaluate MCU code and transfer data to/from the internal memory. If the BKGD/PTA4 pin is held low when the device comes out of a power-on-reset (POR), the device switches into the ACTIVE BACKGROUND DEBUG mode (BDM). The BKGD/PTA4 pin has an internal pullup device or can be connected to VDD in the application, unless there is a need to enter BDM operation after the device as been soldered into the PWB. If in-circuit BDM is desired, the BKGD/PTA4 pin should be connected to VDD through a resistor (~10 k $\Omega$ or greater) which can be over-driven by an external signal. This resistor reduces the possibility of inadvertently activating the debug mode in the application due to an EMC event.
l			When the application programs port A to GPIOs, PTA4 becomes output-only.

NTM88Hxx5S

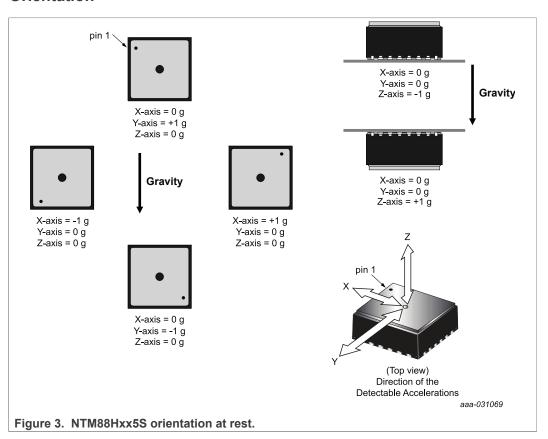
Table 3. Pin description...continued

Symbol	Pin	Function	Description
RST_B	8	Reset / V <sub>PP</sub> programming voltage	The RST_B pin is used for test and establishing the BDM condition and providing the programming voltage source to the internal FLASH memory. This pin can also be used to direct to the MCU to the reset vector. The RST_B pin has an internal pullup device and can be connected to VDD in the application unless there is a need to enter BDM operation after the device as been soldered to the PWB. If in-circuit BDM is desired, the RST_B pin can be left unconnected; but should be connected to VDD through a low impedance resistor (<10 k $\Omega$ ) which can be over-driven by an external signal. This low impedance resistor reduces the possibility of getting into the debug mode in the application due to an EMC event. Activation of the external reset function occurs when the voltage on the RST_B pin goes below 0.3 × V_DD for at least 100 ns before rising above 0.7 × V_DD.
VDDA	9	Analog supply	The analog circuits operate from a single power supply connected to the unit through the VDDA pin. VDDA is the positive supply and GND is the ground. The conductors to the power supply should be connected to the VDDA and GND pins and locally decoupled.  Care should be taken to reduce measurement signal noise by separating the VDD, GND, VDDA, and RFGND pins using a "star" connection such that each metal trace does not share any load currents with other external devices.
GND	10	Digital and analog ground	The digital circuits operate from a single power supply connected to the unit through the VDD and GND pins. GND is the ground. Care should be taken to reduce measurement signal noise by separating the GND and RFGND pins using a "star" connection such that each metal trace does not share any load currents with other external devices.
VDD	11	Digital supply	The digital circuits operate from a single power supply connected to the unit through the VDD and GND pins. VDD is the positive supply. The conductors to the power supply should be connected to the VDD and GND pins and locally decoupled.
VREG	12	1.8 V regulation	The internal regulator for the RF analog circuits requires an external stabilization capacitor to GND.
РТВ0	13	PTB0 / TPMCH0 / AD3	The PTB[0] pin is a general-purpose I/O pin. This pin can be configured as a nominal bidirectional I/O pin with programmable pullup devices. User software must configure the general-purpose I/O pin (PTB[1:0]) so that they do not result in "floating" inputs. PTB0 can be mapped to TPM channel 0, or to ADC channel 3.
РТА3	14	PTA3 / KBI3 / MOSI	The PTA[3] pin is a general-purpose I/O pin. The pulldown devices can only be activated if the wake-up interrupt capability is enabled. User software must configure the general-purpose I/O pins so that they do not result in "floating" inputs. PTA[3] maps to keyboard interrupt function bit [3]. When SPI is enabled, PTA[3] serves as MOSI.
PTA2	15	PTA2 / KBI2 / MISO	The PTA[2] pin is a general-purpose I/O pin. The pulldown devices can only be activated if the wake-up interrupt capability is enabled. User software must configure the general-purpose I/O pins so that they do not result in "floating" inputs. PTA[2] maps to keyboard interrupt function bit [2]. When SPI is enabled, PTA[2] serves as MISO.

Table 3. Pin description...continued

Symbol	Pin	Function	Description
PTA1	16	PTA1 / KBI1 / SCLK	The PTA[1] pin is a general-purpose I/O pin. The pulldown devices can only be activated if the wake-up interrupt capability is enabled. User software must configure the general-purpose I/O pins so that they do not result in "floating" inputs. PTA[1] maps to keyboard interrupt function bit [1]. When SPI is enabled, PTA[1] serves as SCLK
RFGND	17	RF ground	Power in the RF output amplifier is returned to the supply through the RFGND pin. This conductor should be connected to the power supply using a "star" connection such that each metal trace does not share any load currents with other supply pins.
RFOUT	18	RF output	The RFOUT pin is the RF energy data supplied by the unit to an external antenna.
РТА0	19	PTA0 / KBI0 / SS_B / IRQ	The PTA[0] pin is a general-purpose I/O pin. PTA[0] can be configured as a normal bidirectional I/O pin with programmable pullup or pulldown devices and/or wake-up interrupt capability. PTA[0] can be configured for external interrupt (IRQ). The pulldown devices can only be activated if the wake-up interrupt capability is enabled. User software must configure the general-purpose I/O pins so that they do not result in "floating" inputs. PTA[0] maps to keyboard interrupt function bit [0]. When SPI is enabled, PTA0 serves as SS_B.
X1	20	RF crystal input	The X1 pin is for an external 26 MHz crystal to be used by the internal PLL for creating the carrier frequencies and data rates for the RF pin.
X0	21	RF crystal output	The X0 pin is for an external 26 MHz crystal to be used by the internal PLL for creating the carrier frequencies and data rates for the RF pin.
PTB1	22	PTB1 / TPMCH1 / AD4	The PTB[1] pin is a general-purpose I/O pin. This pin can be configured as a nominal bidirectional I/O pin with programmable pullup devices. User software must configure the general-purpose I/O pins (PTB[1:0]) so that they do not result in "floating" inputs. PTB1 can be mapped to TPM channel 1, or to ADC channel 4.
LFB	23	LF input '-'	The LF[A:B] pins can be used by the LF receiver (LFR) as one differential input channel for sensing low-level signals from an external low frequency (LF) coil. The external LF coil should be connected between the LF[A] and the LF[B] pins. Signaling into the LFR pins can place the unit into various diagnostic or operational modes. The LFR is comprised of the detector and the decoder. Each LF[A:B] pin always has an impedance of approximately 500 k $\Omega$ to GND due to the LFR input circuitry. The LFA/LFB pins are used by the LFR when the LFEN control bit is set and are not functional when the LFEN control bit is clear.
LFA	24	LF input '+'	The LF[A:B] pins can be used by the LF receiver (LFR) as one differential input channel for sensing low-level signals from an external low frequency (LF) coil. The external LF coil should be connected between the LF[A] and the LF[B] pins. Signaling into the LFR pins can place the unit into various diagnostic or operational modes. The LFR is comprised of the detector and the decoder. Each LF[A:B] pin always has an impedance of approximately 500 k $\Omega$ to GND due to the LFR input circuitry. The LFA/LFB pins are used by the LFR when the LFEN control bit is set and are not functional when the LFEN control bit is clear.

#### 5.3 Orientation



# 6 Electrical specifications

Tables in the electrical and mechanical specification sections of this data sheet may contain hyperlinked note references in the last cell of the row. The hyperlinks are linked to and defined in Table 4.

Table 4. Electrical and mechanical specification note definition table

Note identifier	Description
А	Parameters tested 100 % at final test.
В	Parameters tested 100 % at unit probe.
С	Verified by characterization, not tested in production.
D	For information only, may be determined by simulation.

### 6.1 Maximum ratings (electrical)

Maximum ratings are the extreme limits the device can be exposed to without permanently damaging it. The device contains circuitry to protect the inputs against damage from high static voltages; however, do not apply voltages higher than the values shown in <u>Table 5</u>. Keep  $V_{IN}$  and  $V_{OUT}$  within the range  $V_{SS} \le (V_{IN} \text{ or } V_{OUT}) \le V_{DD}$ .

In all cases of transient environment, the sensor functional behaviors, parametric behaviors, and dimensions may deviate from the listed steady-state environment

NTM88Hxx5S

All information provided in this document is subject to legal disclaimers.

tolerances as compared to external reference(s).  $\tau$  is the characteristic thermal time constant, from device case ambient to the on-die temperature transducer. Transient environment means less than  $2.3 \times \tau$  seconds since the last step-function transient of a condition; pressure, motion, temperature, supply voltage, electro-magnetic, humidity, vapor, media. Steady-state environment means  $2.3 \times \tau$  or more seconds of stable conditions; pressure, motion, temperature, supply voltage, electro-magnetic, humidity, vapor, media. Examples of step-function transient condition might be tire blow-out, drop impact, ice-bath submersion, battery connection 'bounce', nearby radio transmitter, and so forth.

Table 5. Maximum ratings

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
$V_{DD}$	V <sub>DD</sub> or V <sub>DDA</sub> to V <sub>SS</sub>	$T_L \le T_A \le T_h$	-0.3	_	3.6	V	<u>C</u>
V <sub>IO</sub>	IO pin current, each pin vs $V_{DD}$ / $V_{DDA}$ or $V_{SS}$	$T_{AS}$ Min $\leq T_A \leq T_A$ Max	V <sub>SS</sub> – 0.3	_	V <sub>dd</sub> + 0.3	V	<u>C</u>
I <sub>IO</sub>	IO pin current, pin vs $V_{DD}$ / $V_{DDA}$ or $V_{SS}$	$T_L \le T_A \le T_H$ , $V_{DDR}$ Min $\le V_{DD} \le V_{DDR}$ Max	-10	_	10	mA	<u>C</u>
I <sub>SUBIO</sub>	Substrate current injection, all IO pins except LFA LFB current from pin to $V_{SS} - 0.3 \text{ V}$	$T_L \le T_A \le T_H$ , $V_{DDR}$ Min $\le V_{DD} \le V_{DDR}$ Max	_	600	_	μΑ	<u>C</u>
I <sub>SUBLF</sub>	Substrate current injection, LFA LFB current from pin to V <sub>SS</sub> – 0.3 V	$T_L \le T_A \le T_H$ , $V_{DDF} Min \le V_{DD} \le V_{DDF} Max$	_	2	_	mA	<u>C</u>
I <sub>LATCH</sub>	Latch-up current, current to/from pin to V <sub>DD</sub> / V <sub>DDA</sub> + 0.3 V	$T_L \le T_A \le T_H$ , $V_{DDR}$ Min $\le V_{DD} \le V_{DDR}$ Max	-100	_	100	mA	<u>C</u>
ESD <sub>HBM</sub>	Electrostatic discharge, human body model (HBM), all pins except RF, and LF	T <sub>A</sub> = 25 °C, V <sub>DD</sub> = 3.0 V	-2000	_	2000	V	<u>C</u>
ESD <sub>HBM</sub>	Electrostatic discharge, human body model (HBM), RF, and LF	T <sub>A</sub> = 25 °C, V <sub>DD</sub> = 3.0 V	-2000	_	2000	V	<u>C</u>
ESD <sub>CDM</sub>	Electrostatic discharge, charged device model (CDM), all pins	T <sub>A</sub> = 25 °C, V <sub>DD</sub> = 3.0 V	-500	_	500	V	<u>C</u>
T <sub>STG</sub>	Unpowered storage, temperature range	_	-50	_	150	°C	<u>C</u>

### 6.2 Operating conditions

The limits normally expected in the application that define the range of operation.

Table 6. Operating range

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
$V_{DDR}$	Operating voltage range, Parameter register retention where Min = V <sub>L</sub> , Typ = 3.0 V, Max = V <sub>H</sub>	$T_{AS}$ Min $\leq T_{A} \leq T_{AS}$ Max	1.2	3.0	3.6	V	<u>C</u>
V <sub>DDS</sub>	Operating voltage range, MCU and SW, Flash Read, RF TX, Voltage Measurement where Min = V <sub>L</sub> , Typ = 3.0 V, Max = V <sub>H</sub>	$T_{AS}$ Min $\leq T_{A} \leq T_{AS}$ Max	V <sub>LVDRF</sub>	3.0	3.6	V	<u>C</u>
$V_{DDM}$	Operating voltage range, Pressure, Temperature and Acceleration Measurements where Min = $V_L$ , Typ = 3.0 V, Max = $V_H$	$T_{AS}$ Min $\leq T_{A} \leq T_{AS}$ Max	2.1	3.0	3.6	V	C
V <sub>DDF</sub>	Operating voltage range, Flash Programming and LF RX, where Min = V <sub>L</sub> , Typ = 3.0 V, Max = V <sub>H</sub>	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	2.1	3.0	3.6	V	<u>C</u>

NTM88Hxx5S

All information provided in this document is subject to legal disclaimers.

Table 6. Operating range...continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
T <sub>AS</sub>	Operating temperature range, Full functionality except LF RX, and Flash Programming where Min = T <sub>L</sub> , Typ = 25 °C, Max = T <sub>H</sub>	V <sub>DDS</sub> Min ≤ V <sub>DD</sub> ≤ V <sub>DDS</sub> Max	-40	25	125	°C	<u>C</u>
T <sub>AF</sub>	Operating temperature range, Operating voltage range, Full functionality, including LF RX, and Flash programming	$V_{DDF} Min \le V_{DD} \le V_{DDF} Max$	-20	25	85	°C	<u>C</u>
T <sub>A-EXC</sub>	Operating temperature range excursion; 12 excursions of 15 minutes ea. (all Tolerances may be out of spec)	V <sub>DDM</sub> Min ≤ V <sub>DD</sub> ≤ V <sub>DDM</sub> Max	_		150	°C	<u>C</u>
I <sub>DD1</sub>	Supply Current; Stop1 Mode (only LFO, PWU, and param. reg. On)	Typ = 25 °C, 3.0 V, Max = T <sub>AS</sub> Min to Max & V <sub>DDR</sub> Min to Max	_	0.18	18	μА	<u>B</u>
I <sub>DD4</sub>	Supply Current; Stop4 Mode (only MCU, RF, and LF disabled)	Typ = 25 °C, 3.0 V, Max = T <sub>AS</sub> Min to Max & V <sub>DDS</sub> Min to Max	_	75	125	μА	<u>B</u>
I <sub>DDLFS</sub>	Supply Current; Standby LF sniff (and Stop1 equivalent)	Typ = 25 °C, 3.0 V, Max = T <sub>AF</sub> Min to Max & V <sub>DDF</sub> Min to Max	_	4.8	8.1	μА	<u>C</u>
I <sub>DDLFD</sub>	Supply Current; Standby LF Decoding (and Stop1 equivalent)	Typ = 25 °C, 3.0 V, Max = T <sub>AF</sub> Min to Max & V <sub>DDF</sub> Min to Max	_	11.3	14.3	μА	<u>C</u>
i <sub>DDR5K</sub>	Supply Current; MCU Run 500 kHz (and RF and LF disabled)	Typ = 25 °C, 3.0 V, Max = T <sub>AS</sub> Min to Max & V <sub>DDS</sub> Min to Max	_	0.8	1.0	mA	<u>C</u>
I <sub>DDR1M</sub>	Supply Current; MCU Run 1 MHz (and RF and LF disabled)	Typ = 25 °C, 3.0 V, Max = T <sub>AS</sub> Min to Max & V <sub>DDS</sub> Min to Max	_	1.0	1.2	mA	<u>C</u>
I <sub>DDR2M</sub>	Supply Current; MCU Run 2 MHz (and RF and LF disabled)	Typ = 25 °C, 3.0 V, Max = T <sub>AS</sub> Min to Max & V <sub>DDS</sub> Min to Max	_	1.42	1.6	mA	<u>C</u>
I <sub>DDR4M</sub>	Supply Current; MCU Run 4 MHz (and RF and LF disabled)	Typ = 25 °C, 3.0 V, Max = T <sub>AS</sub> Min to Max & V <sub>DDS</sub> Min to Max	_	2.1	2.5	mA	<u>B</u>
I <sub>DDRFT3</sub>	Supply Current; RF TX 5 dBm, 315 MHz (and Stop1 equivalent)	T <sub>A</sub> = 25 °C, V <sub>DD</sub> = 3.0 V	_	5.7	6.1	mA	<u>B</u>
I <sub>DDRFT4</sub>	Supply Current; RF TX 5 dBm, 434 MHz (and Stop1 equivalent)	T <sub>A</sub> = 25 °C, V <sub>DD</sub> = 3.0 V	_	6.3	6.8	mA	<u>B</u>
I <sub>DDRFTx1</sub>	Supply Current Increase w/ BOOST = 1 RF TX 5 dBm (and Stop1 equivalent)	T <sub>A</sub> = 25 °C, V <sub>DD</sub> = 3.0 V	_	_	0.6	mA	<u>C</u>
I <sub>DDIF0</sub>	Supply Current, RF Interframe period, IFPD = 0	Typ = 25 °C, 3.0 V, Max = T <sub>AS</sub> Min to Max & V <sub>DDS</sub> Min to Max	_	610	870	μА	<u>C</u>
I <sub>DDIF1</sub>	Supply Current, RF Interframe period, IFPD = 1	Typ = 25 °C, 3.0 V, Max = T <sub>AS</sub> Min to Max & V <sub>DDS</sub> Min to Max	_	19	36	μА	<u>C</u>
I <sub>DDA</sub> or I <sub>DDP</sub>	Supply Current Peak; Accel. or Pressure Measurements (and Stop4 equivalent)	Typ = 25 °C, 3.0 V, Max = T <sub>AS</sub> Min to Max & V <sub>DDM</sub> Min to Max	_	2.8	3.15	mA	<u>C</u>
I <sub>DDV</sub> or I <sub>DDT</sub>	Supply Current Peak; Voltage or Temp. Measurements (and Stop4 equivalent)	Typ = 25 °C, 3.0 V, Max = T <sub>AS</sub> Min to Max & V <sub>DDM</sub> Min to Max	_	2.8	3.8	mA	<u>C</u>

# 6.3 Charge consumptions

Table 7. Charge consumptions

 $T_L \le T_A \le T_H$ , unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
Q <sub>wake</sub>	Stop1 to run charge consumption, F <sub>bus</sub> set for 4 MHz	$V_{DDM}$ Min $\leq V_{DD} \leq V_{DDM}$ Max	_	0.10	_	μΑ- sec	<u>C</u>
QPA <sub>r512</sub>	Pressure or accelerometer charge consumption; Raw 512 µs settling per sample	V <sub>DDM</sub> Min ≤ V <sub>DD</sub> ≤ V <sub>DDM</sub> Max	_	0.95	_	μΑ- sec	<u>C</u>
QPA <sub>r2048</sub>	Pressure or accelerometer charge consumption; Raw 2048 µs settling per sample	V <sub>DDM</sub> Min ≤ V <sub>DD</sub> ≤ V <sub>DDM</sub> Max	_	1.85	_	μΑ- sec	<u>C</u>
QP <sub>c3</sub>	Pressure charge consumption; Compensation third order per sample	$V_{DDM}$ Min $\leq V_{DD} \leq V_{DDM}$ Max	_	1.77	_	μΑ- sec	D
QA <sub>c2</sub>	Accelerometer charge consumption; Compensation second order per sample	V <sub>DDM</sub> Min ≤ V <sub>DD</sub> ≤ V <sub>DDM</sub> Max	_	1.95	_	μΑ- sec	D
QVT <sub>r50</sub>	Voltage or temperature charge consumption; Raw 50 μs conversion per sample	V <sub>DDM</sub> Min ≤ V <sub>DD</sub> ≤ V <sub>DDM</sub> Max	_	0.2	_	μΑ- sec	<u>C</u>
QVT <sub>c250</sub>	Voltage or temperature charge consumption; Compensation ~0.25 ms per sample	V <sub>DDM</sub> Min ≤ V <sub>DD</sub> ≤ V <sub>DDM</sub> Max	_	0.50	_	μΑ- sec	<u>D</u>

# 6.4 Clocks and thresholds

Table 8. Clocks and thresholds

 $V_{DDS} \, \mathit{Min} \leq V_{DD} \leq V_{DDS} \, \mathit{Max}, \; T_{AS} \, \mathit{Min} \leq T_{A} \leq T_{AS} \, \mathit{Max}, \; \mathit{unless otherwise specified}.$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
f <sub>BUS</sub>	MCU bus frequency multiple of HFO	V <sub>DD</sub> > V <sub>LVDRF</sub>	_	0.5	_	x HFO	<u>D</u>
f <sub>HF0</sub>	High frequency oscillator, multiple of MFO	V <sub>DD</sub> > V <sub>LVDRF</sub>	_	64	_	x MFO	<u>D</u>
t <sub>HFOST</sub>	Stabilization time	_	_	300	1000	μs	<u>D</u>
f <sub>MFO</sub>	Medium frequency oscillator	V <sub>DD</sub> > V <sub>LVDRF</sub>	107	125	135	kHz	<u>A</u>
f <sub>LFO</sub>	Low frequency oscillator	_	504	_	1512	Hz	<u>B</u>
f <sub>LFRO</sub>	LFR Clock (derived from LFRO)	_	120	129	139	kHz	<u>B</u>
t <sub>STOP1</sub>	MCU wake-up time	From Stop1 to 1 <sup>st</sup> instruction, 4 MHz	_	50	70	μs	<u>C</u>
t <sub>STOP4</sub>	MCU wake-up time	From Stop4 to 1 <sup>st</sup> instruction, 4 MHz	_	25	35	μs	<u>C</u>
t <sub>LV</sub>	Low voltage times	$V_{DD} < V_{LVx}$	_	_	10	μs	<u>D</u>
$V_{LVWLF}$	Low voltage warning (LVW)	Lower threshold, V <sub>DD</sub> falling	1.95	_	2.2	V	<u>C</u>
$V_{LVWLR}$	Low voltage warning (LVW)	Lower threshold, V <sub>DD</sub> rising	2.02	_	2.1	V	<u>C</u>
$V_{LVWHF}$	Low voltage warning (LVW)	Higher threshold, V <sub>DD</sub> falling	2.28	_	2.54	V	<u>C</u>
$V_{LVWHR}$	Low voltage warning (LVW)	Higher threshold, V <sub>DD</sub> rising	2.34	_	2.61	V	<u>C</u>
$V_{LVDLF}$	Low voltage detection (LVD)	Lower threshold, V <sub>DD</sub> falling	1.79	_	1.96	V	<u>C</u>
$V_{LVDLR}$	Low voltage detection (LVD)	Lower threshold, V <sub>DD</sub> rising	1.87	_	2.03	V	<u>C</u>

NTM88Hxx5S

All information provided in this document is subject to legal disclaimers.

Table 8. Clocks and thresholds...continued

 $V_{DDS}$   $Min \le V_{DD} \le V_{DDS}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
$V_{LVDHF}$	Low voltage detection (LVD)	Higher threshold, V <sub>DD</sub> falling	1.95	_	2.2	V	<u>C</u>
$V_{LVDHR}$	Low voltage detection (LVD)	Higher threshold, V <sub>DD</sub> rising	2.02	_	2.1	V	<u>C</u>
V <sub>LVDRF</sub>	RF LVD	V <sub>DD</sub> falling	1.6	_	2.1	V	<u>C</u>
T <sub>FDR</sub>	Flash memory data retention	_	10	_	_	Yr	<u>D</u>

#### 6.5 Power-on reset operation

When power is initially applied to the device, or when the supply voltage drops below the  $V_{POR}$  level, the POR circuit causes a reset condition. As the supply voltage rises, the LVD circuit holds the chip in reset until the supply has risen above the level determined by LVDV bit. Both the POR bit and the LVD bit in SRS are set following a POR.

Table 9. Power-on reset

 $V_{DDS} \ \mathit{Min} \leq V_{DD} \leq V_{DDS} \ \mathit{Max}, \ T_{AS} \ \mathit{Min} \leq T_{A} \leq T_{AS} \ \mathit{Max}, \ \mathit{unless otherwise specified}.$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
t <sub>R</sub>	Power on reset (POR)	V <sub>DD</sub> risetime to avoid latch up	_	_	1	s	<u>C</u>
t <sub>POR</sub>	Power on reset (POR)	Time for V <sub>DD</sub> < 0.5 V to assure POR	70	_	_	μs	<u>C</u>
V <sub>PORR</sub>	Power on reset (POR)	Rising voltage to release reset	_	_	2.1	V	<u>C</u>
V <sub>PORA</sub>	Power on reset (POR)	Falling voltage to assert reset	0.8	_	_	V	<u>C</u>

# 6.6 GPIO port pins

Table 10. GPIO port pins

 $V_{DDS} \ \mathit{Min} \leq V_{DD} \leq V_{DDS} \ \mathit{Max}, \ T_{AS} \ \mathit{Min} \leq T_{A} \leq T_{AS} \ \mathit{Max}, \ \mathit{unless otherwise specified}.$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
V <sub>OH</sub>	Output high voltage	I <sub>LOAD</sub> = 5 mA	V <sub>DD</sub> – 0.35	_	_	V	<u>D</u>
V <sub>OL</sub>	Output low voltage	I <sub>LOAD</sub> = 5 mA	_	_	V <sub>SS</sub> + 0.35	V	<u>D</u>
V <sub>IHn</sub>	Input high voltage	$2.3 \text{ V} \le \text{V}_{DD} \le \text{V}_{H}, \text{ T}_{A} = \text{T}_{L}, \text{T}_{H}$	0.7 × V <sub>DD</sub> / V <sub>DDA</sub>	_	V <sub>DD</sub> / V <sub>DDA</sub>	V	<u>D</u>
V <sub>IHIV</sub>	Input high voltage	$V_{DD} \le 2.3 \text{ V}, T_A = 25 \text{ °C}$	0.85 × V <sub>DD</sub> / V <sub>DDA</sub>	_	V <sub>DD</sub> / V <sub>DDA</sub>	V	D
V <sub>ILn</sub>	Input low voltage	$2.3 \text{ V} \leq \text{V}_{DD} \leq \text{V}_{H}, \text{ T}_{A} = \text{T}_{L}, \text{T}_{H}$	V <sub>SS</sub>	_	0.35 × V <sub>DD</sub> / V <sub>DDA</sub>	V	D
V <sub>ILIv</sub>	Input low voltage	$V_{DD} \le 2.3 \text{ V}, T_A = 25 ^{\circ}\text{C}$	V <sub>SS</sub>	_	0.28 × V <sub>DD</sub> / V <sub>DDA</sub>	V	D
I <sub>IH</sub>	Input high current, PTA0:3	Pulldown disabled; V <sub>IH</sub> Min	-1	_	+1	μA	<u>D</u>
I <sub>IHp</sub>	Input high current, PTA0:3	Pulldown enabled; V <sub>IH</sub> Min	0	_	120	μA	<u>D</u>
I <sub>IL</sub>	Input low current, PTA0:3	Pullup disabled; V <sub>IL</sub> Max	-1	_	+1	μA	<u>D</u>
I <sub>ILp</sub>	Input low current, PTA0:3	Pullup enabled; V <sub>IL</sub> Max	-120	_	0	μA	<u>D</u>
I <sub>IH-IL</sub>	Input current PTA4 only	$V_{\text{IH}}$ Min and $V_{\text{IL}}$ Max	-120	_	120	μA	<u>D</u>

NTM88Hxx5S

All information provided in this document is subject to legal disclaimers.

Table 10. GPIO port pins...continued

 $V_{DDS}$   $Min \le V_{DD} \le V_{DDS}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
C <sub>IO</sub>	Pin capacitance	V <sub>DD</sub> = 3.0 V	0	_	15	pF	<u>D</u>
C <sub>MISO</sub>	MISO load capacitance	V <sub>DD</sub> = 3.0 V	_	_	50	pF	<u>D</u>

# 6.7 SPI timing characteristics

Table 11. SPI timing

 $V_{DDS}$   $Min \le V_{DD} \le V_{DDS}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
t <sub>SSMIN</sub>	SS_B asserted period	_	1	_	_	f <sub>BUS</sub> period	<u>D</u>
t <sub>ACCESS</sub>	SS_B low to MISO	_	_	_	50	ns	<u>D</u>
t <sub>LEAD</sub>	SS_B low to SCLK start	_	50	_	_	ns	<u>D</u>
t <sub>SETUP</sub>	MOSI to SCLK start	_	20	_	_	ns	<u>D</u>
t <sub>SCLK</sub>	SCLK period	_	100	_	_	ns	<u>D</u>
t <sub>SCLKH</sub>	SCLK high portion	_	35	_	_	ns	<u>D</u>
t <sub>SCLKL</sub>	SCLK low portion	_	35	-	_	ns	<u>D</u>
t <sub>SCLKR</sub>	SCLK risetime	_	_	10	25	ns	<u>D</u>
t <sub>SCLKF</sub>	SCLK fall time	_	_	10	25	ns	<u>D</u>
t <sub>VALID</sub>	MISO valid transition time	_	_	_	30	ns	<u>D</u>
t <sub>HOLD_IN</sub>	MOSI hold time	_	10	-	_	ns	<u>D</u>
t <sub>HOLD_OUT</sub>	SCLK high to MISO transition start	_	0	_	_	ns	<u>D</u>
t <sub>LAG</sub>	Final SCLK low to SS_B high	_	60	-	_	ns	<u>D</u>
t <sub>DISABLE</sub>	SS_B high to MISO 3-state	_	_	_	60	ns	<u>D</u>
t <sub>SS_REJ</sub>	SS_B noise rejection period	_	_	_	5	ns	<u>D</u>
t <sub>SSCLK</sub>	SS_B high to SCLK high	_	50	-	_	ns	<u>D</u>
t <sub>CLKSS</sub>	SCLK high to SCLK low	_	50	-	_	ns	<u>D</u>
t <sub>SSN</sub>	SS_B not asserted period	_	6	_	_	f <sub>BUS</sub> period	<u>D</u>
t <sub>LEAD-WU</sub>	Wake-up by SS_B low to SCLK start	_	1	-	_	ms	<u>D</u>
t <sub>SPI_EN</sub>	SPI enable by SS_B low after V <sub>DD</sub> > V <sub>PORR</sub>	_	200	_	_	μs	<u>D</u>

# 6.8 Temperature measurement characteristics

#### Table 12. Temperature measurement

 $V_{DDM} \, Min \leq V_{DD} \leq V_{DDM} \, Max, \, T_{AS} \, Min \leq T_{A} \leq T_{AS} \, Max, \, unless \, otherwise \, specified.$ 

Transfer function:  $T \, ^{\circ}C = (1 \, ^{\circ}C \, / \, LSB \times T_{CODE}) - 55 \, ^{\circ}C$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
DT <sub>MAX-MIN</sub>	Sensitivity	_	0.93	1	1.08	°C / LSB	<u>C</u>
T <sub>ERROR</sub>	Error	_	_	0	_	LSB	<u>C</u>
T <sub>UNDER</sub>	Underflow	_	_	1	_	LSB	<u>C</u>

NTM88Hxx5S

All information provided in this document is subject to legal disclaimers.

Table 12. Temperature measurement...continued

 $V_{DDM}$   $Min \le V_{DD} \le V_{DDM}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Transfer function:  $T \, ^{\circ}C = (1 \, ^{\circ}C \, / \, LSB \times T_{CODE}) - 55 \, ^{\circ}C$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
T <sub>OVER</sub>	Overflow	_	_	255	_	LSB	<u>C</u>
T <sub>MIN</sub>	Temperature measurement	T <sub>A</sub> = -50 °C	_	5	_	LSB	<u>D</u>
T <sub>RATE-MIN</sub>	Temperature measurement	T <sub>A</sub> = -40 °C	11	15	19	LSB	<u>C</u>
T <sub>CODE</sub>	Temperature measurement	T <sub>A</sub> = -20 °C	32	35	38	LSB	<u>A</u>
T <sub>CODE</sub>	Temperature measurement	T <sub>A</sub> = 0 °C	52	55	58	LSB	<u>C</u>
T <sub>CODE</sub>	Temperature measurement	T <sub>A</sub> = 25 °C	77	80	83	LSB	<u>B</u>
T <sub>CODE</sub>	Temperature measurement	T <sub>A</sub> = 70 °C	122	125	128	LSB	<u>C</u>
T <sub>CODE</sub>	Temperature measurement	T <sub>A</sub> = 85 °C	137	140	143	LSB	A
T <sub>CODE</sub>	Temperature measurement	T <sub>A</sub> = 105 °C	156	160	164	LSB	<u>C</u>
T <sub>RATE-MAX</sub>	Temperature measurement	T <sub>A</sub> = 125 °C	175	180	185	LSB	<u>B</u>
T <sub>MAX</sub>	Temperature measurement	T <sub>A</sub> = 150 °C [1]	_	205	_	LSB	<u>D</u>
T <sub>DRIFT</sub>	Temperature measurement drift	_	-3	_	+3	LSB	<u>C</u>

<sup>[1]</sup> Temperature excursions, time at T<sub>MAX</sub> must not exceed 12 events of 15 minutes duration during the product lifetime.

# 6.9 Voltage measurement characteristics

Table 13. Voltage measurement characteristics

 $V_{DDS}$   $Min \le V_{DD} \le V_{DDS}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Transfer function:  $V = (0.01 \text{ V/LSB} \times V_{CODE}) + 1.22 \text{ V}$ 

Interpolated limits between -40 °C to 0 °C and between 50 °C to 125 °C.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
DV <sub>MAX-MIN</sub>	Sensitivity	_	9	10	12	mV / LSB	<u>C</u>
V <sub>ERROR</sub>	Error	_	_	0	_	LSB	<u>C</u>
V <sub>UNDER</sub>	Underflow	_	_	1	_	LSB	<u>C</u>
V <sub>OVER</sub>	Overflow	_	_	255	_	LSB	<u>C</u>
V <sub>CODE</sub>	V <sub>DD</sub> voltage, 2.8 V	0 °C ≤ T <sub>A</sub> ≤ 50 °C, V <sub>DD</sub> = 2.8 V	153	158	163	LSB	<u>C</u>
V <sub>CODE</sub>	V <sub>DD</sub> voltage, 3.0 V	$0  ^{\circ}\text{C} \le \text{T}_{\text{A}} \le 50  ^{\circ}\text{C},  \text{V}_{\text{DD}} = 3.0  \text{V}$	173	178	183	LSB	<u>C</u>
V <sub>CODE</sub>	V <sub>DD</sub> voltage, 3.3 V	0 °C ≤ T <sub>A</sub> ≤ 50 °C, V <sub>DD</sub> = 3.3 V	203	208	213	LSB	<u>C</u>
V <sub>MIN</sub>	V <sub>DD</sub> voltage, 1.8 V	_	38	58	78	LSB	<u>C</u>
V <sub>CODE</sub>	V <sub>DD</sub> voltage, 2.1 V	_	68	88	108	LSB	<u>B</u>
V <sub>CODE</sub>	V <sub>DD</sub> voltage, 2.3 V	-40 °C ≤ T <sub>A</sub> ≤ 0 °C or 50 °C ≤ T <sub>A</sub> ≤ 125 °C, V <sub>DD</sub> = 2.3 V	98	108	118	LSB	<u>C</u>
V <sub>CODE</sub>	V <sub>DD</sub> voltage, 2.8 V	-40 °C ≤ T <sub>A</sub> ≤ 0 °C or 50 °C ≤ T <sub>A</sub> ≤ 125 °C, V <sub>DD</sub> = 2.8 V	148	158	168	LSB	<u>C</u>
V <sub>CODE</sub>	V <sub>DD</sub> voltage, 3.0 V	-40 °C ≤ T <sub>A</sub> ≤ 0 °C or 50 °C ≤ T <sub>A</sub> ≤ 125 °C, V <sub>DD</sub> = 3.0 V	168	178	188	LSB	<u>B</u>
V <sub>CODE</sub>	V <sub>DD</sub> voltage, 3.3 V	-40 °C ≤ T <sub>A</sub> ≤ 0 °C or 50 °C ≤ T <sub>A</sub> ≤ 125 °C, V <sub>DD</sub> = 3.3 V	198	208	218	LSB	<u>C</u>
V <sub>MAX</sub>	V <sub>DD</sub> voltage, 3.6 V	_	228	238	248	LSB	<u>C</u>
V <sub>DRIFT</sub>	Voltage drift	_	-3	-	+3	LSB	<u>C</u>

NTM88Hxx5S

Table 14. External pin voltage measurement

 $V_{DDS}$   $Min \le V_{DD} \le V_{DDS}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified. Transfer function:  $V = (V_{DD} \ V / LSB \times GxCODE) / 1023$ , where x = 0 for PTB0, 1 for PTB1

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
ΔGxMAX- MIN	Sensitivity	_	_	V <sub>dd</sub> / 1023	_	V / LSB	<u>C</u>
GxERROR	Error	Status = \$01	_	0	_	LSB	<u>C</u>
GxCODE	Voltage measurement, V = 0 V	Status = \$00		0	_	LSB	<u>C</u>
GxCODE	Voltage measurement, V = VDD V	_	_	1023	_	LSB	<u>C</u>
GxDRIFT	Voltage measurement drift	_	-1	_	+1	LSB	<u>C</u>

#### 6.10 Pressure measurement characteristics

Unless otherwise noted, stated tolerances are valid only with Initial Sample Delay [ISD3:0] set for > 2.5 ms and MCU placed in STOP4 mode.

### 6.10.1 Pressure measurement characteristic (90 kPa to 930 kPa) range

Table 15. Pressure measurement characteristics (90 kPa to 930 kPa) range

 $V_{DDM} \, Min \leq V_{DD} \leq V_{DDM} \, Max, \, T_{AS} \, Min \leq T_{A} \leq T_{AS} \, Max, \, unless \, otherwise \, specified.$ 

Transfer function:  $P \ kPa = (0.824 \ kPa / LSB \times P_{CODE}) + 88.353 \ kPa$ 

Interpolated limits between 105 °C and 125 °C.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
DP <sub>MAX-MIN</sub>	Sensitivity	_	0.78	0.824	0.86	kPa / LSB	<u>C</u>
P <sub>ERROR</sub>	Error	_	_	0	_	LSB	<u>C</u>
P <sub>UNDER</sub>	Underflow	FW error status bit 0 = 1	_	1	_	LSB	<u>C</u>
P <sub>OVER</sub>	Overflow	FW error status bit 0 = 1	_	1023	_	LSB	<u>C</u>
P <sub>MIN</sub>	Proof pressure, 90 kPa	-40 °C ≤ T <sub>A</sub> ≤ 105 °C	_	2	11	LSB	<u>D</u>
P <sub>CODE</sub>	Proof pressure, 230 kPa	-40 °C ≤ T <sub>A</sub> ≤ 105 °C	166	172	178	LSB	<u>C</u>
P <sub>CODE</sub>	Proof pressure, 370 kPa	-40 °C ≤ T <sub>A</sub> ≤ 105 °C	336	342	348	LSB	<u>A</u>
P <sub>CODE</sub>	Proof pressure, 510 kPa	-40 °C ≤ T <sub>A</sub> ≤ 105 °C	506	512	518	LSB	<u>C</u>
P <sub>CODE</sub>	Proof pressure, 650 kPa	-40 °C ≤ T <sub>A</sub> ≤ 105 °C	676	682	688	LSB	<u>C</u>
P <sub>CODE</sub>	Proof pressure, 790 kPa	-40 °C ≤ T <sub>A</sub> ≤ 105 °C	846	852	858	LSB	<u>A</u>
P <sub>MAX</sub>	Proof pressure, 930 kPa	-40 °C ≤ T <sub>A</sub> ≤ 105 °C	1016	1022	_	LSB	<u>D</u>
P <sub>MIN</sub>	Proof pressure, 90 kPa	T <sub>A</sub> = 125 °C	_	2	22	LSB	<u>D</u>
P <sub>CODE</sub>	Proof pressure, 230 kPa	T <sub>A</sub> = 125 °C	151	172	192	LSB	<u>C</u>
P <sub>CODE</sub>	Proof pressure, 370 kPa	T <sub>A</sub> = 125 °C	322	342	362	LSB	<u>C</u>
P <sub>CODE</sub>	Proof pressure, 510 kPa	T <sub>A</sub> = 125 °C	492	512	532	LSB	<u>C</u>
P <sub>CODE</sub>	Proof pressure, 650 kPa	T <sub>A</sub> = 125 °C	662	682	702	LSB	<u>C</u>
P <sub>CODE</sub>	Proof pressure, 790 kPa	T <sub>A</sub> = 125 °C	832	852	872	LSB	<u>C</u>
P <sub>MAX</sub>	Proof pressure, 930 kPa	T <sub>A</sub> = 125 °C	1002	1022	_	LSB	<u>D</u>
P <sub>DRIFT</sub>	Pressure drift	_	_	_	±6	LSB	<u>C</u>

#### 6.11 Acceleration measurement characteristics

Unless otherwise noted, stated tolerances are valid only with Initial Sample Delay [ISD3:0] set for > 2.5 ms and MCU placed in STOP4 mode.

### 6.11.1 Acceleration measurement characteristics (-80 g to +90 g) range option

Table 16. Acceleration measurement characteristic (-80 g to +90 g) range option

 $V_{DDS} \, Min \le V_{DD} \le V_{DDS} \, Max, \, T_{AS} \, Min \le T_{A} \le T_{AS} \, Max, \, unless \, otherwise \, specified.$ 

Transfer Function: Offset Step 7 A g's =  $(0.020 \text{ g/LSB} \times A_{\text{CODE}}) - 10.039 \text{ g}$ Interpolated limits between  $-40 \,^{\circ}\text{C}$  to  $-20 \,^{\circ}\text{C}$  and between  $85 \,^{\circ}\text{C}$  to  $125 \,^{\circ}\text{C}$ 

Symbol **Parameter** Conditions Min Max Unit Notes Typ  $\mathsf{DA}_{\mathsf{MAX-MIN}}$ Sensitivity 0.014 0.020 0.034 g/ <u>C</u> LSB **A**ERROR Frror 0 LSB <u>C</u> AUNDER Underflow FW error status bit 0 = 1 1 LSB С Overflow FW error status bit 0 = 1 1023 LSB <u>C</u> AOVER Acceleration measurement, -80 g, -20 °C ≤ T<sub>A</sub> ≤ 85 °C 2 LSB D A<sub>MIN0</sub> Offset step 0 Acceleration measurement, -75 g, -20 °C ≤ T<sub>A</sub> ≤ 85 °C LSB 257 A<sub>CODE0</sub> D Offset Step 0 Acceleration measurement, -70 g, -20 °C ≤ T<sub>A</sub> ≤ 85 °C 512 LSB D Acopeo Offset Step 0 A<sub>CODE0</sub> Acceleration measurement, -65 g, -20 °C ≤ T<sub>A</sub> ≤ 85 °C 767 LSB D Offset Step 0 Acceleration measurement, -60 g, -20 °C ≤ T<sub>A</sub> ≤ 85 °C 1022 LSB D  $A_{MAX0}$ Offset Step 0 A<sub>MIN7</sub> Acceleration measurement, -10 g, -20 °C ≤ T<sub>A</sub> ≤ 85 °C 2 180 LSB D Offset Step 7 Acceleration measurement, -5 g, -20 °C ≤ T<sub>A</sub> ≤ 85 °C LSB A<sub>CODE7</sub> 104 257 410 D Offset Step 7 Acceleration measurement, 0 g, –20 °C ≤ T<sub>A</sub> ≤ 85 °C 384 512 640 LSB A A<sub>CODE7</sub> Offset Step 7 –20 °C ≤ T<sub>Δ</sub> ≤ 85 °C Acceleration measurement, 5 g, 614 767 920 LSB D A<sub>CODE7</sub> Offset Step 7 Acceleration measurement, 10 g, -20 °C ≤ T<sub>A</sub> ≤ 85 °C 844 1022 LSB  $A_{MAX7}$ D Offset Step 7 Acceleration measurement, -10 g,  $T_A = -40$  °C and 125 °C 2 216 LSB D  $A_{MIN7}$ Offset Step 7 Acceleration measurement, -5 g,  $T_A = -40 \,^{\circ}\text{C}$  and 125  $^{\circ}\text{C}$ 73 257 441 LSB A<sub>CODE7</sub> D Offset Step 7 Acceleration measurement, 0 q,  $T_A = -40 \,^{\circ}\text{C}$  and 125  $^{\circ}\text{C}$ 359 512 665 LSB D A<sub>CODE7</sub> Offset Step 7 Acceleration measurement, 5 g,  $T_A = -40 \,^{\circ}\text{C}$  and 125  $^{\circ}\text{C}$ 583 767 951 LSB A<sub>CODE7</sub> D Offset Step 7 Acceleration measurement, 10 g,  $T_A = -40 \,^{\circ}\text{C}$  and 125  $^{\circ}\text{C}$ 808 1022 LSB A<sub>MAX7</sub> D Offset Step 7 Acceleration measurement, 70 g, -20 °C ≤ T<sub>A</sub> ≤ 85 °C LSB 2 D A<sub>MIN15</sub> Offset Step 15 Acceleration measurement, 75 g. -20 °C ≤ T<sub>A</sub> ≤ 85 °C 257 LSB D A<sub>CODE15</sub> Offset Step 15

NTM88Hxx5S

All information provided in this document is subject to legal disclaimers.

Table 16. Acceleration measurement characteristic (-80 g to +90 g) range option...continued

 $V_{DDS}$   $Min \le V_{DD} \le V_{DDS}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Transfer Function: Offset Step 7 A g's =  $(0.020~g/LSB \times A_{CODE}) - 10.039~g$ Interpolated limits between  $-40~^{\circ}C$  to  $-20~^{\circ}C$  and between 85  $^{\circ}C$  to 125  $^{\circ}C$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
A <sub>CODE15</sub>	Acceleration measurement, 80 g, Offset Step 15	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	512	_	LSB	<u>D</u>
A <sub>CODE15</sub>	Acceleration measurement, 85 g, Offset Step 15	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	767	_	LSB	<u>D</u>
A <sub>MAX15</sub>	Acceleration measurement, 90 g, Offset Step 15	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	1022	_	LSB	<u>D</u>
A <sub>DRIFT</sub>	Inertia drift	_	<b>-</b> 5	_	+5	LSB	<u>C</u>

### 6.11.2 Acceleration measurement characteristic (-360 g to +400 g) range option

#### Table 17. Acceleration measurement characteristic (-360 g to +400 g) range option

 $V_{DDM}$   $Min \le V_{DD} \le V_{DDM}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Transfer Function: Offset Step 7 A g's =  $(0.088 \text{ g/LSB} \times A_{CODE}) - 45.176 \text{ g}$ 

Interpolated limits between -40 °C to -20 °C and between 85 °C to 125 °C

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
DdrA <sub>MAX</sub> -	Sensitivity	_	0.074	0.088	0.108	g/ LSB	<u>C</u>
A <sub>ERROR</sub>	Error	_	_	0	_	LSB	<u>C</u>
A <sub>UNDER</sub>	Underflow	FW error status bit 0 = 1	_	1	_	LSB	<u>C</u>
A <sub>OVER</sub>	Overflow	FW error status bit 0 = 1	_	1023	_	LSB	<u>C</u>
A <sub>MIN0</sub>	Acceleration measurement, –360 g, Offset step 0	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	2	_	LSB	D
A <sub>CODE0</sub>	Acceleration measurement, –338 g, Offset step 0	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	257	_	LSB	<u>D</u>
A <sub>CODE0</sub>	Acceleration measurement, –315 g, Offset step 0	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	512	_	LSB	<u>D</u>
A <sub>CODE0</sub>	Acceleration measurement, –293 g, Offset step 0	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	767	_	LSB	<u>D</u>
A <sub>MAX0</sub>	Acceleration measurement, –270 g, Offset step 0	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	1022	_	LSB	<u>D</u>
A <sub>MIN7</sub>	Acceleration measurement, –45 g, Offset step 7	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	2	81	LSB	<u>D</u>
A <sub>CODE7</sub>	Acceleration measurement, –22.5 g, Offset step 7	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	203	257	311	LSB	<u>D</u>
A <sub>CODE7</sub>	Acceleration measurement, 0 g, Offset step 7	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	483	512	541	LSB	<u>A</u>
A <sub>CODE7</sub>	Acceleration measurement, 22.5 g, Offset step 7	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	713	767	821	LSB	<u>D</u>
A <sub>MAX7</sub>	Acceleration measurement, 45 g, Offset step 7	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	943	1022	_	LSB	<u>D</u>
A <sub>MIN7</sub>	Acceleration measurement, –45 g, Offset step 7	T <sub>A</sub> = -40 °C and 125 °C	_	2	97	LSB	<u>D</u>
A <sub>CODE7</sub>	Acceleration measurement, –22.5 g, Offset step 7	$T_A = -40 ^{\circ}\text{C}$ and 125 $^{\circ}\text{C}$	192	257	322	LSB	<u>D</u>

Table 17. Acceleration measurement characteristic (-360 g to +400 g) range option...continued

 $V_{DDM}$   $Min \le V_{DD} \le V_{DDM}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Transfer Function: Offset Step 7 A g's =  $(0.088 \text{ g/LSB} \times A_{CODE}) - 45.176 \text{ g}$ Interpolated limits between -40 °C to -20 °C and between 85 °C to 125 °C

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
A <sub>CODE7</sub>	Acceleration measurement, 0 g, Offset step 7	T <sub>A</sub> = -40 °C and 125 °C	478	512	546	LSB	<u>D</u>
A <sub>CODE7</sub>	Acceleration measurement, 22.5 g, Offset step 7	T <sub>A</sub> = -40 °C and 125 °C	702	767	832	LSB	<u>D</u>
A <sub>MAX7</sub>	Acceleration measurement, 45 g, Offset step 7	T <sub>A</sub> = -40 °C and 125 °C	927	1022	_	LSB	<u>D</u>
A <sub>MIN15</sub>	Acceleration measurement, 315 g, Offset Step 15	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	2	_	LSB	<u>D</u>
A <sub>CODE15</sub>	Acceleration measurement, 338 g, Offset Step 15	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	257	_	LSB	<u>D</u>
A <sub>CODE15</sub>	Acceleration measurement, 360 g, Offset Step 15	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	512	_	LSB	<u>D</u>
A <sub>CODE15</sub>	Acceleration measurement, 383 g, Offset Step 15	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	767	_	LSB	<u>D</u>
A <sub>MAX15</sub>	Acceleration measurement, 405 g, Offset Step 15	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	1022	_	LSB	<u>D</u>
A <sub>DRIFT</sub>	Acceleration measurement drift	_	-4	_	+4	LSB	<u>C</u>

# 6.11.3 Acceleration measurement characteristic (-120 g to +520 g) range option

# Table 18. Acceleration measurement characteristic (-120 g to +520 g) range option

 $V_{DDM} \, Min \leq V_{DD} \leq V_{DDM} \, Max, \, T_{AS} \, Min \leq T_{A} \leq T_{AS} \, Max, \, unless \, otherwise \, specified.$ 

Transfer Function: Offset Step 2 A g's =  $(0.102 \text{ g/LSB} \times A_{CODE}) - 52.204 \text{ g}$ 

Interpolated limits between –40 °C to –20 °C and between 85 °C to 125 °C

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
DA <sub>MAX-MIN</sub>	Sensitivity	_	0.087	0.102	0.124	g/ LSB	<u>C</u>
A <sub>ERROR</sub>	Error	_	_	0	_	LSB	<u>C</u>
A <sub>UNDER</sub>	Underflow	FW error status bit 0 = 1	_	1	_	LSB	<u>C</u>
A <sub>OVER</sub>	Overflow	FW error status bit 0 = 1		1023	_	LSB	<u>C</u>
A <sub>MIN0</sub>	Acceleration measurement, –124 g, Offset step 0	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	2	_	LSB	D
A <sub>CODE0</sub>	Acceleration measurement, –98 g, Offset step 0	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	257	_	LSB	D
A <sub>CODE0</sub>	Acceleration measurement, –72 g, Offset step 0	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	512	_	LSB	<u>D</u>
A <sub>CODE0</sub>	Acceleration measurement, –46 g, Offset step 0	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	767	_	LSB	<u>D</u>
A <sub>MAX0</sub>	Acceleration measurement, –20 g, Offset step 0	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	1022	_	LSB	<u>D</u>
A <sub>MIN2</sub>	Acceleration measurement, –52 g, Offset step 2	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	2	77	LSB	<u>D</u>
A <sub>CODE2</sub>	Acceleration measurement, –26 g, Offset step 2	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	207	257	307	LSB	<u>D</u>

Table 18. Acceleration measurement characteristic (-120 g to +520 g) range option...continued

 $V_{DDM}$   $Min \le V_{DD} \le V_{DDM}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Transfer Function: Offset Step 2 A g's =  $(0.102~g/LSB \times A_{CODE}) - 52.204~g$  Interpolated limits between  $-40~^{\circ}C$  to  $-20~^{\circ}C$  and between 85  $^{\circ}C$  to 125  $^{\circ}C$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
A <sub>CODE2</sub>	Acceleration measurement, 0 g, Offset step 2	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	487	512	537	LSB	A
A <sub>CODE2</sub>	Acceleration measurement, 26 g, Offset step 2	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	717	767	817	LSB	<u>D</u>
A <sub>MAX2</sub>	Acceleration measurement, 52 g, Offset step 2	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	947	1022	_	LSB	<u>D</u>
A <sub>MIN2</sub>	Acceleration measurement, –52 g, Offset step 2	T <sub>A</sub> = –40 °C and 125 °C	-	2	92	LSB	D
A <sub>CODE2</sub>	Acceleration measurement, –26 g, Offset step 2	T <sub>A</sub> = –40 °C and 125 °C	197	257	317	LSB	D
A <sub>CODE2</sub>	Acceleration measurement, 0 g, Offset step 2	T <sub>A</sub> = –40 °C and 125 °C	482	512	542	LSB	D
A <sub>CODE2</sub>	Acceleration measurement, 26 g, Offset step 2	T <sub>A</sub> = –40 °C and 125 °C	707	767	827	LSB	<u>D</u>
A <sub>MAX2</sub>	Acceleration measurement, 52 g, Offset step 2	T <sub>A</sub> = -40 °C and 125 °C	932	1022	1112	LSB	<u>D</u>
A <sub>MIN15</sub>	Acceleration measurement, 416 g, Offset Step 15	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	-	2	_	LSB	D
A <sub>CODE15</sub>	Acceleration measurement, 442 g, Offset Step 15	-20 °C ≤ T <sub>A</sub> ≤ 85 °C	-	257	_	LSB	D
A <sub>CODE15</sub>	Acceleration measurement, 468 g, Offset Step 15	–20 °C ≤ T <sub>A</sub> ≤ 85 °C	_	512	_	LSB	<u>D</u>
A <sub>CODE15</sub>	Acceleration measurement, 494 g, Offset Step 15	–20 °C ≤ T <sub>A</sub> ≤ 85 °C	-	767	_	LSB	<u>D</u>
A <sub>MAX15</sub>	Acceleration measurement, 520 g, Offset Step 15	–20 °C ≤ T <sub>A</sub> ≤ 85 °C	-	1022	_	LSB	<u>D</u>
A <sub>DRIFT</sub>	Acceleration measurement drift	_	-4	_	+4	LSB	<u>C</u>

### 6.11.4 Acceleration measurement characteristic (-175 g to +550 g) range option

# Table 19. Acceleration measurement characteristic (-175 g to +550 g) range option

 $V_{DDM}$   $Min \le V_{DD} \le V_{DDM}$  Max,  $T_{AS}$   $Min \le T_A \le T_{AS}$  Max, unless otherwise specified.

Transfer Function: Offset Step 7 A g's =  $(0.343 \text{ g/LSB} \times A_{CODE}) - 175.686 \text{ g}$ 

Interpolated limits between –40 °C to –20 °C and between 85 °C to 125 °C

Due to the inverted polarity calibration where the offset steps are in reverse order, the standard library function

TPMS\_READ\_DYNAMIC\_ACCEL is not compatible with this range option.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
ΔA <sub>MAX-MIN</sub>	Sensitivity		0.302	0.343	0.398	g/ LSB	<u>C</u>
A <sub>ERROR</sub>	Error			0		LSB	<u>C</u>
A <sub>UNDER</sub>	Underflow	FW error status bit 0 = 1		1		LSB	<u>C</u>
A <sub>OVER</sub>	Overflow	FW error status bit 0 = 1		1023		LSB	<u>C</u>
A <sub>MIN</sub> 4	Acceleration measurement, 200 g, Offset step 4	-20 °C ≤ TA ≤ 85 °C	_	2	_	LSB	<u>D</u>
A <sub>CODE</sub> 4	Acceleration measurement, 288 g, Offset step 4	-20 °C ≤ TA ≤ 85 °C	_	257	_	LSB	<u>D</u>

NTM88Hxx5S

All information provided in this document is subject to legal disclaimers.

Table 19. Acceleration measurement characteristic (-175 g to +550 g) range option...continued

 $V_{DDM}$   $Min \le V_{DD} \le V_{DDM}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Transfer Function: Offset Step 7 A g's =  $(0.343 \text{ g/LSB} \times A_{CODE}) - 175.686 \text{ g}$ 

Interpolated limits between -40 °C to -20 °C and between 85 °C to 125 °C

Due to the inverted polarity calibration where the offset steps are in reverse order, the standard library function

TPMS\_READ\_DYNAMIC\_ACCEL is not compatible with this range option.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
A <sub>CODE</sub> 4	Acceleration measurement, 375 g, Offset step 4	-20 °C ≤ TA ≤ 85 °C	_	512	_	LSB	<u>D</u>
A <sub>CODE</sub> 4	Acceleration measurement, 463 g, Offset step 4	-20 °C ≤ TA ≤ 85 °C	_	767	_	LSB	<u>D</u>
A <sub>MAX</sub> 4	Acceleration measurement, 550 g, Offset step 4	-20 °C ≤ TA ≤ 85 °C	_	1022	_	LSB	<u>D</u>
A <sub>MIN</sub> 5	Acceleration measurement, 75 g, Offset step 5	-20 °C ≤ TA ≤ 85 °C	_	2	_	LSB	<u>D</u>
A <sub>CODE</sub> 5	Acceleration measurement, 163 g, Offset step 5	-20 °C ≤ TA ≤ 85 °C	_	257	_	LSB	<u>D</u>
A <sub>CODE</sub> 5	Acceleration measurement, 250 g, Offset step 5	-20 °C ≤ TA ≤ 85 °C	_	512	_	LSB	<u>D</u>
A <sub>CODE</sub> 5	Acceleration measurement, 338 g, Offset step 5	-20 °C ≤ TA ≤ 85 °C	_	767	_	LSB	<u>D</u>
A <sub>MAX</sub> 5	Acceleration measurement, 425 g, Offset step 5	-20 °C ≤ TA ≤ 85 °C	_	1022	_	LSB	<u>D</u>
A <sub>MIN</sub> 6	Acceleration measurement, -50 g, Offset step 6	-20 °C ≤ TA ≤ 85 °C	_	2	_	LSB	<u>D</u>
A <sub>CODE</sub> 6	Acceleration measurement, 38 g, Offset step 6	-20 °C ≤ TA ≤ 85 °C	_	257	_	LSB	<u>D</u>
ACODE6	Acceleration measurement, 125 g, Offset step 6	-20 °C ≤ TA ≤ 85 °C	_	512	_	LSB	<u>D</u>
A <sub>CODE</sub> 6	Acceleration measurement, 213 g, Offset step 6	-20 °C ≤ TA ≤ 85 °C	_	767	_	LSB	<u>D</u>
A <sub>MAX</sub> 6	Acceleration measurement, 300 g, Offset step 6	-20 °C ≤ TA ≤ 85 °C	_	1022	_	LSB	D
A <sub>MIN</sub> 7	Acceleration measurement, –175 g, Offset step 7	-20 °C ≤ TA ≤ 85 °C	_	2	60	LSB	<u>D</u>
A <sub>CODE</sub> 7	Acceleration measurement, –88 g, Offset step 7	-20 °C ≤ TA ≤ 85 °C	224	257	290	LSB	<u>D</u>
A <sub>CODE</sub> 7	Acceleration measurement, 0 g, Offset step 7	-20 °C ≤ TA ≤ 85 °C	504	512	520	LSB	<u>A</u>
A <sub>CODE</sub> 7	Acceleration measurement, 88 g, Offset step 7	-20 °C ≤ TA ≤ 85 °C	734	767	800	LSB	<u>D</u>
A <sub>MAX</sub> 7	Acceleration measurement, 175 g, Offset step 7	-20 °C ≤ TA ≤ 85 °C	964	1022	_	LSB	D
A <sub>MIN</sub> 7	Acceleration measurement, –175 g, Offset step 7	TA = -40 °C & 125 °C	_	2	72	LSB	<u>D</u>
A <sub>CODE</sub> 7	Acceleration measurement, –88 g, Offset step 7	TA = -40 °C & 125 °C	218	257	296	LSB	<u>D</u>
A <sub>CODE</sub> 7	Acceleration measurement, 0 g, Offset step 7	TA = -40 °C & 125 °C	503	512	525	LSB	<u>D</u>
A <sub>CODE</sub> 7	Acceleration measurement, 88 g, Offset step 7	TA = -40 °C & 125 °C	728	767	806	LSB	<u>D</u>

NTM88Hxx5S

All information provided in this document is subject to legal disclaimers.

Table 19. Acceleration measurement characteristic (-175 g to +550 g) range option...continued

 $V_{DDM}$   $Min \le V_{DD} \le V_{DDM}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Transfer Function: Offset Step 7 A g's =  $(0.343 \text{ g/LSB} \times A_{CODE}) - 175.686 \text{ g}$ 

Interpolated limits between -40 °C to -20 °C and between 85 °C to 125 °C

Due to the inverted polarity calibration where the offset steps are in reverse order, the standard library function

TPMS\_READ\_DYNAMIC\_ACCEL is not compatible with this range option.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
A <sub>MAX</sub> 7	Acceleration measurement, 175 g, Offset step 7	TA = -40 °C & 125 °C	952	1022	_	LSB	<u>D</u>
A <sub>MIN</sub> 8	Acceleration measurement, –300 g, Offset step 8	-20 °C ≤ TA ≤ 85 °C	_	2	_	LSB	<u>D</u>
A <sub>CODE</sub> 8	Acceleration measurement, –213 g, Offset step 8	-20 °C ≤ TA ≤ 85 °C	_	257	_	LSB	<u>D</u>
A <sub>CODE</sub> 8	Acceleration measurement, –125 g, Offset step 8	-20 °C ≤ TA ≤ 85 °C	_	512		LSB	<u>D</u>
A <sub>CODE</sub> 8	Acceleration measurement, –38 g, Offset step 8	-20 °C ≤ TA ≤ 85 °C	_	767	_	LSB	<u>D</u>
A <sub>MAX</sub> 8	Acceleration measurement, 50 g, Offset step 8	-20 °C ≤ TA ≤ 85 °C	_	1022	_	LSB	<u>D</u>
A <sub>MIN</sub> 9	Acceleration measurement, –425 g, Offset step 9	-20 °C ≤ TA ≤ 85 °C	_	2	_	LSB	<u>D</u>
A <sub>CODE</sub> 9	Acceleration measurement, –338 g, Offset step 9	-20 °C ≤ TA ≤ 85 °C	_	257	_	LSB	<u>D</u>
A <sub>CODE</sub> 9	Acceleration measurement, –250 g, Offset step 9	-20 °C ≤ TA ≤ 85 °C	_	512	_	LSB	<u>D</u>
A <sub>CODE</sub> 9	Acceleration measurement, –163 g, Offset step 9	-20 °C ≤ TA ≤ 85 °C	_	767	_	LSB	<u>D</u>
A <sub>MAX</sub> 9	Acceleration measurement, –75 g, Offset step 9	-20 °C ≤ TA ≤ 85 °C	_	1022	_	LSB	<u>D</u>
A <sub>MIN</sub> 10	Acceleration measurement, –550 g, Offset step 10	-20 °C ≤ TA ≤ 85 °C	_	2	_	LSB	<u>D</u>
A <sub>CODE</sub> 10	Acceleration measurement, –463 g, Offset step 10	-20 °C ≤ TA ≤ 85 °C	_	257	_	LSB	<u>D</u>
A <sub>CODE</sub> 10	Acceleration measurement, –375 g, Offset step 10	-20 °C ≤ TA ≤ 85 °C	_	512	_	LSB	<u>D</u>
A <sub>CODE</sub> 10	Acceleration measurement, –288 g, Offset step 10	-20 °C ≤ TA ≤ 85 °C	_	767	_	LSB	<u>D</u>
A <sub>MAX</sub> 10	Acceleration measurement, –200 g, Offset step 10	-20 °C ≤ TA ≤ 85 °C	_	1022	_	LSB	<u>D</u>
A <sub>DRIFT</sub>	Inertia drift		-4		+4	LSB	<u>C</u>

# 6.11.5 Acceleration measurement characteristic (-400 g to +400 g) range option

#### Table 20. Acceleration measurement characteristic (-400 g to +400 g) range option

 $V_{DDM}$   $Min \le V_{DD} \le V_{DDM}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Transfer Function: Offset Step 7 A g's =  $(0.294 \text{ g/LSB} \times A_{CODE}) - 150.59 \text{ g}$ 

Interpolated limits between -40 °C to -20 °C and between 85 °C to 125 °C

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
ΔA <sub>MAX-MIN</sub>	Sensitivity		0.260	0.294	0.342	g / LSB	<u>C</u>
A <sub>ERROR</sub>	Error			0		LSB	<u>C</u>

NTM88Hxx5S

All information provided in this document is subject to legal disclaimers.

Table 20. Acceleration measurement characteristic (-400 g to +400 g) range option...continued

 $V_{DDM}$   $Min \le V_{DD} \le V_{DDM}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified.

Transfer Function: Offset Step 7 A g's =  $(0.294 \text{ g/LSB} \times A_{CODE}) - 150.59 \text{ g}$ Interpolated limits between -40 °C to -20 °C and between 85 °C to 125 °C

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
A <sub>UNDER</sub>	Underflow	FW error status bit 0 = 1		1		LSB	<u>C</u>
A <sub>OVER</sub>	Overflow	FW error status bit 0 = 1		1023		LSB	<u>C</u>
A <sub>MIN</sub> 6	Acceleration measurement, –400 g, Offset step 6	-20 °C ≤ TA ≤ 85 °C	_	2		LSB	D
A <sub>CODE</sub> 6	Acceleration measurement, –325 g, Offset step 6	-20 °C ≤ TA ≤ 85 °C	_	257	_	LSB	<u>D</u>
A <sub>CODE</sub> 6	Acceleration measurement, –250 g, Offset step 6	-20 °C ≤ TA ≤ 85 °C	_	512	_	LSB	<u>D</u>
A <sub>CODE</sub> 6	Acceleration measurement, –175 g, Offset step 6	-20 °C ≤ TA ≤ 85 °C	_	767	_	LSB	<u>D</u>
A <sub>MAX</sub> 6	Acceleration measurement, –100 g, Offset step 6	-20 °C ≤ TA ≤ 85 °C	_	1022	_	LSB	<u>D</u>
A <sub>MIN</sub> 7	Acceleration measurement, –150 g, Offset step 7	-20 °C ≤ TA ≤ 85 °C	_	2	61	LSB	<u>D</u>
A <sub>CODE</sub> 7	Acceleration measurement, –75 g, Offset step 7	-20 °C ≤ TA ≤ 85 °C	223	257	291	LSB	<u>D</u>
A <sub>CODE</sub> 7	Acceleration measurement, 0 g, Offset step 7	-20 °C ≤ TA ≤ 85 °C	503	512	521	LSB	<u>A</u>
A <sub>CODE</sub> 7	Acceleration measurement, 75 g, Offset step 7	-20 °C ≤ TA ≤ 85 °C	733	767	801	LSB	D
A <sub>MAX</sub> 7	Acceleration measurement, 150 g, Offset step 7	-20 °C ≤ TA ≤ 85 °C	963	1022	_	LSB	<u>D</u>
A <sub>MIN</sub> 7	Acceleration measurement, –150 g, Offset step 7	TA = -40 °C & 125 °C	_	2	73	LSB	<u>D</u>
A <sub>CODE</sub> 7	Acceleration measurement, –75 g, Offset step 7	TA = -40 °C & 125 °C	216	257	298	LSB	<u>D</u>
A <sub>CODE</sub> 7	Acceleration measurement, 0 g, Offset step 7	TA = -40 °C & 125 °C	501	512	523	LSB	<u>D</u>
A <sub>CODE</sub> 7	Acceleration measurement, 75 g, Offset step 7	TA = -40 °C & 125 °C	726	767	808	LSB	<u>D</u>
A <sub>MAX</sub> 7	Acceleration measurement, 150 g, Offset step 7	TA = -40 °C & 125 °C	951	1022	_	LSB	D
A <sub>MIN</sub> 8	Acceleration measurement, 100 g, Offset step 8	-20 °C ≤ TA ≤ 85 °C	_	2	_	LSB	D
A <sub>CODE</sub> 8	Acceleration measurement, 175 g, Offset step 8	-20 °C ≤ TA ≤ 85 °C	_	257	_	LSB	D
A <sub>CODE</sub> 8	Acceleration measurement, 250 g, Offset step 8	-20 °C ≤ TA ≤ 85 °C	_	512	_	LSB	D
A <sub>CODE</sub> 8	Acceleration measurement, 325 g, Offset step 8	-20 °C ≤ TA ≤ 85 °C	_	767	_	LSB	D
A <sub>MAX</sub> 8	Acceleration measurement, 400 g, Offset step 8	-20 °C ≤ TA ≤ 85 °C	_	1022	_	LSB	<u>D</u>
A <sub>DRIFT</sub>	Inertia drift		-5		+5	LSB	<u>C</u>

# 6.12 Low frequency receiver characteristics

Table 21. LFR characteristics

 $V_{DDF}$   $Min \le V_{DD} \le V_{DDF}$  Max,  $T_{AF}$   $Min \le T_A \le T_{AF}$  Max, unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
R <sub>LFDF</sub>	LFA / LFB load resistance	_	0.8	_	4	ΜΩ	<u>D</u>
DR <sub>LFIN</sub>	Dynamic range, f <sub>C</sub> at BW <sub>ACC</sub>	Data mode, always detect	56	_	_	dB	<u>D</u>
V <sub>IN-AD-H</sub>	Sensitivity, high - carrier and data modes	Always detect	_	_	3.0	mVPP	<u>B</u>
V <sub>IN-ND-H</sub>	Sensitivity, high - carrier and data modes	Never detect	0.25	_	_	mVPP	<u>B</u>
V <sub>IN-AD-L</sub>	Sensitivity, low - carrier and data modes	Always detect	_	_	12.0	mVPP	<u>B</u>
V <sub>IN-ND-L</sub>	Sensitivity, low - carrier and data modes	Never detect	4.0	_	_	mVPP	<u>B</u>
MD	Modulation depth	_	70	_	100	%	<u>C</u>
BRLF	Baud rate	_	3788	3906	4032	Bit/s	<u>C</u>
DCM	Manchester duty cycle tolerance	_	_	40 / 60	45 / 55	%	<u>C</u>
DCN	NRZ duty cycle tolerance	_	_	50 / 50	45 / 55	%	<u>C</u>
MER	Message error rate	_		5	_	%	<u>C</u>
BW <sub>ACC</sub>	Bandwidth	Always detect	≥ 88	_	≤ 175	kHz	<u>C</u>
BW <sub>REJ</sub>	Bandwidth	Never detect	< 88	-	> 175	kHz	<u>C</u>
t <sub>LF</sub>	Signal rise / decay time constant, carrier envelope	_	15.3	_	_	μs	<u>D</u>

# 6.13 Radio frequency transmitter characteristics

Table 22. Radio frequency transmitter characteristics

 $V_{DDS}$   $Min \le V_{DD} \le V_{DDS}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified. All conditions characterized with NDK NX2016SA 26.000 MHz crystal.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
PRF3	Nominal output power w/ 50 Ω matching network	315 MHz, 25 °C, 3.0 V PWR[4:0] = 0 1 1 0 0	_	5	_	dBm	<u>C</u>
PRF4	Nominal output power w/ 50 Ω matching network	434 MHz, 25 °C, 3.0 V PWR[4:0] = 0 1 1 1 0	_	5	_	dBm	<u>C</u>
PRF	Output power, range	_	-1.5	_	8	dBm	<u>C</u>
PRFSTEP	Output power, step size	_	_	0.5	_	dBm	<u>C</u>
PRFMINp	Output power, minimum PRF vs. T <sub>A</sub> and V <sub>DD</sub> under control of FW TPMS_RF_DYNAMIC_POWER	$-40 ^{\circ}\text{C} \le \text{TA} \le 0 ^{\circ}\text{C}$ and $1.8 \text{V} \le \text{V}_{DD} \le 2.5 \text{V}$ , or $0 ^{\circ}\text{C} \le \text{T}_{A} \le 125 ^{\circ}\text{C}$ and $2.5 \text{V} \le \text{V}_{DD} \le 3.6 \text{V}$	3		_	dBm	C
PRFMINn	Output power, minimum PRF vs. T <sub>A</sub> and V <sub>DD</sub> under control of FW TPMS_RF_DYNAMIC_POWER	25 °C ≤ T <sub>A</sub> ≤ 60 °C and 2.5 V ≤ V <sub>DD</sub> ≤ 3.6 V	5	_	_	dBm	<u>C</u>
PRFMIN00	Output power, Step = 00	_	_	-10	_	dBm	<u>C</u>
FSK	Frequency shift key step	_	_	3.17	_	kHz	<u>D</u>

NTM88Hxx5S

All information provided in this document is subject to legal disclaimers.

**Table 22. Radio frequency transmitter characteristics...**continued  $V_{DDS}$   $Min \le V_{DD} \le V_{DDS}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified. All conditions characterized with NDK NX2016SA 26.000 MHz crystal.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
MOOK	On off key modulation depth	_	60	80	_	dBc	<u>C</u>
BRRF	Baud rate range	_	1.2	_	38.4	kbits/ sec	<u>C</u>
DR	Manchester encoding bit/s accuracy, based on MFO	_	-5	_	+5	%	<u>D</u>
DC	Modulation duty cycle, FSK, and OOK	_	45	50	55	%	<u>C</u>
FxTAL	External crystal frequency, all conditions	_	_	26	_	MHz	<u>D</u>
t <sub>S-RCTS</sub>	Fixed portion, RF start-up process	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	500	620	μs	<u>C</u>
Bits	Variable portion, RF start-up process	_	_	3	_	bit times	<u>C</u>
tRF2	Total RF start time, write of SEND bit to start of RF output, at 2000 bit/s, where tRF = tS-RCTS + (Bits * bit/s^-1	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	2	2.2	ms	C
tRF9	Total RF start time, write of SEND bit to start of RF output, at 9600 bit/s, where tRF = tS-RCTS + (Bits * bit/s^-1	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	800	920	μs	<u>C</u>
tRF20	Total RF start time, write of SEND bit to start of RF output, at 20000 bit/s, where tRF = tS-RCTS + (Bits * bit/s^-1	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	640	760	μs	<u>C</u>
H2	Harmonic 2, 315 MHz or 434 MHz, with 50 $\Omega$ matching network, power step adjusted to reach target power in each domain.	_	_	_	-22	dBc	C
НЗ	Harmonic 3, 315 MHz or 434 MHz, with 50 $\Omega$ matching network, power step adjusted to reach target power in each domain.	_	_	_	-31	dBc	<u>C</u>
H4	Harmonic 4, 315 MHz or 434 MHz, with 50 $\Omega$ matching network, power step adjusted to reach target power in each domain.	_	_	_	-40	dBc	<u>C</u>
N3PH10k	315 MHz phase noise, ±10 kHz, Boost = 0	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	-87	-78	dBc / Hz	<u>C</u>
N3PH100k	315 MHz phase noise, ±100 kHz, Boost = 0	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	-95	-87	dBc / Hz	<u>C</u>
N3PH1M	315 MHz phase noise, ±1 MHz, Boost = 0	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	-82	-77	dBc / Hz	<u>C</u>
N31PH10k	315 MHz phase noise, ±10 kHz, Boost = 1	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	-75	-66	dBc / Hz	<u>C</u>
N31PH100k	315 MHz phase noise, ±100 kHz, Boost = 1	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	-83	-75	dBc / Hz	<u>C</u>
N31PH1M	315 MHz phase noise, ±1 MHz, Boost = 1	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	-96	-93	dBc / Hz	<u>C</u>

**Table 22. Radio frequency transmitter characteristics...**continued  $V_{DDS}$   $Min \le V_{DD} \le V_{DDS}$  Max,  $T_{AS}$   $Min \le T_{A} \le T_{AS}$  Max, unless otherwise specified. All conditions characterized with NDK NX2016SA 26.000 MHz crystal.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
N4PH10k	434 MHz phase noise, ±10 kHz, Boost = 0	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	-85	<b>–</b> 75	dBc / Hz	C
N4PH100k	434 MHz phase noise, ±100 kHz, Boost = 0	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	-92	-83	dBc / Hz	<u>C</u>
N4PH1M	434 MHz phase noise, ±1 MHz, Boost = 0	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	-83	<del>-</del> 78	dBc / Hz	<u>C</u>
NPH10M	Phase noise, ±10 MHz	Typ = 25 °C, 3.0 V, Max = TAS Min to Max & VDDS Min to Max	_	-105	-101	dBc / Hz	<u>C</u>
NSP315	Spurious noise, <1 GHz, 10 kHz BW 315 MHz FCC 15.231a-e	_	_	_	-30	dBc	<u>C</u>
NSPUG	Spurious noise, < 1 GHz, 10 kHz BW 434 MHz ETSI EN300220	_	_	_	-40	dBc	<u>C</u>
NSPOG	Spurious noise, >1 GHz, 10 kHz BW 434 MHz ETSI EN300220	_	_	_	-40	dBc	<u>C</u>
OBWKF	Occupied bandwidth, < ±35 kHz FSK up to 19.2 kbit/s Korea, MIC 2007-63	_	_	_	200	kHz	<u>C</u>
OBWKO	Occupied bandwidth, OOK up to 9.6 kbit/s, Korea, MIC 2007-64	_	_	_	200	kHz	<u>C</u>
OBWJF	Occupied bandwidth, < ±45 kHz FSK up to 38.4 kbit/s, Japan, ARIB STD-T93	_	_	_	400	kHz	<u>C</u>
OBWJO	Occupied bandwidth, OOK up to 19.2 kbit/s, Japan, ARIB STD-T94	_	_	_	600	kHz	<u>C</u>
ML	Oscillation margin	_	850	_	_	Ω	<u>D</u>
f <sub>XCO</sub>	Internal oscillator accuracy	_	-10	_	+10	ppm	<u>D</u>
VAREGOK	RF $V_{reg}$ capacitor Pre-charge voltage - Note: 0.47 $\mu$ F $V_{reg}$ capacitor connected.	V <sub>DDS</sub> ≥ 2.1 V	_	1.5	_	V	<u>C</u>
t <sub>AREGOK</sub>	RF $V_{reg}$ capacitor Pre-charge Process - Note: 0.47 $\mu$ F $V_{reg}$ capacitor connected, additional to $t_{S-RCTS}$	V <sub>DDS</sub> ≥ 2.1 V	_	630	1000	μSec	<u>D</u>

The firmware routine TPMS\_PRECHARGE\_EN performs the pre-charge of RF  $V_{reg}$  capacitor. When the pre-charge is successful, the execution time of the routine corresponds to  $t_{AREGOK}$  duration. When the pre-charge fails, the routine exits after a timeout longer than  $t_{AREGOK}$  max duration.

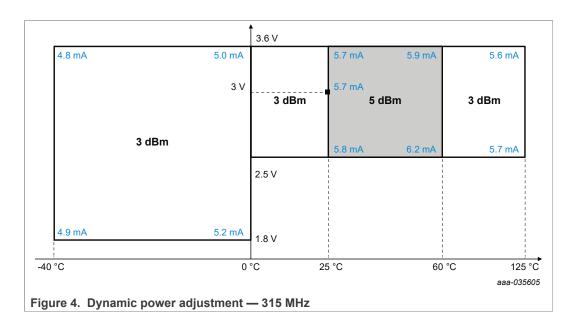
### 6.14 Power consumption RF transmissions

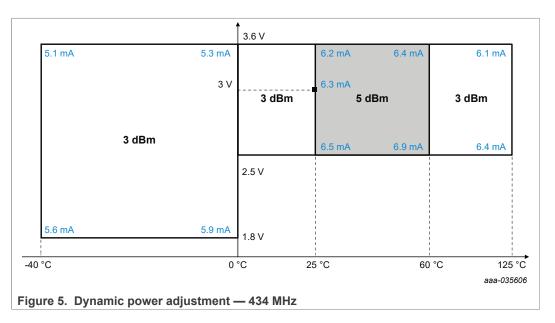
Using the TPMS\_RF\_DYNAMIC\_POWER firmware routine<sup>2</sup> allows adjusting the power step in order to compensate for variations of output power versus temperature and voltage. This routine is associated to a part-to-part trimming that initially adjusts the power step to compensate for process variations.

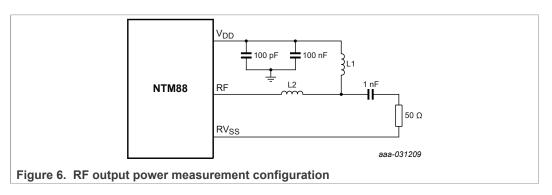
NTM88Hxx5S

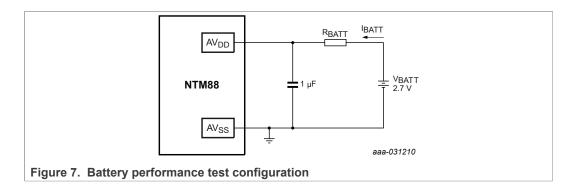
All information provided in this document is subject to legal disclaimers.

<sup>&</sup>lt;sup>2</sup> Refer to user manual, UM11227. [1]









# 7 Mechanical specifications

# 7.1 Maximum ratings (mechanical)

Maximum ratings are the extreme limits the device can be exposed without permanent damage. The device contains circuitry to protect the inputs against damage from high static voltages; however, do not apply voltages higher than the values shown in <u>Table 23</u>. Keep  $V_{IN}$  and  $V_{OUT}$  within the range  $V_{SS} \le (V_{IN} \text{ or } V_{OUT}) \le V_{DD}$ .

Table 23. Maximum ratings

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	Notes
P <sub>burst1k</sub>	Pressure transducer, minimum burst pressure	≤ 1200 kPa rating	2000	_	_	kPa	<u>D</u>
f <sub>P0</sub>	Pressure transducer, minimum natural resonance frequency	_	_	5	_	MHz	<u>D</u>
Q <sub>P</sub>	Pressure transducer damping ratio	_	_	1	_	_	<u>D</u>
PA <sub>N</sub>	Pressure transducer, sensitivity to vertical acceleration	–500 g ≤ A ≤ +500 g	_	0	_	Pa/g	<u>C</u>
PA <sub>neg</sub>	Pressure transducer, sensitivity to vertical acceleration	A < -500 g	2	4.5	6.5	Pa/g	<u>C</u>
PA <sub>pos</sub>	Pressure transducer, sensitivity to vertical acceleration	A > +500 g	-6.5	-4.5	-2	Pa/g	<u>C</u>
f <sub>A0</sub>	Accelerometer, minimum natural resonance frequency	_	7	_	16	kHz	<u>D</u>
Q <sub>A</sub>	Accelerometer, damping ratio	_	1	_	4	_	<u>D</u>
AP1k	Accelerometer, sensitivity to pressure	90 kPa ≤ P ≤ 1200 kPa	-1.5	_	+1.5	g / 1000 kPa	<u>C</u>
A <sub>stop2h</sub>	Accelerometer, minimum acceleration to reach travel stop	≤ 100 g rating	-200	_	+200	g	<u>D</u>
A <sub>stop7h</sub>	Accelerometer, minimum acceleration to reach travel stop	> 100 g rating	-700	_	+700	g	<u>D</u>
A <sub>CROSS</sub>	Accelerometer, maximum cross axis sensitivity	$X \rightarrow Z$ , or $Z \rightarrow X$ , or $X \rightarrow Y$ , or $Z \rightarrow Y$	<b>–</b> 5	_	+5	%	<u>D</u>
m	Package Mass	_	_	0.2	_	gram	<u>D</u>
τ	Thermal time constant	_	_	101	_	sec	<u>D</u>

# 7.2 Media compatibility

Media compatibility is based on media and test method described in NXP specification NXPOMS-999116894-4501. Consult your sales representative for more details and specific requirements.

# 8 Mounting recommendations

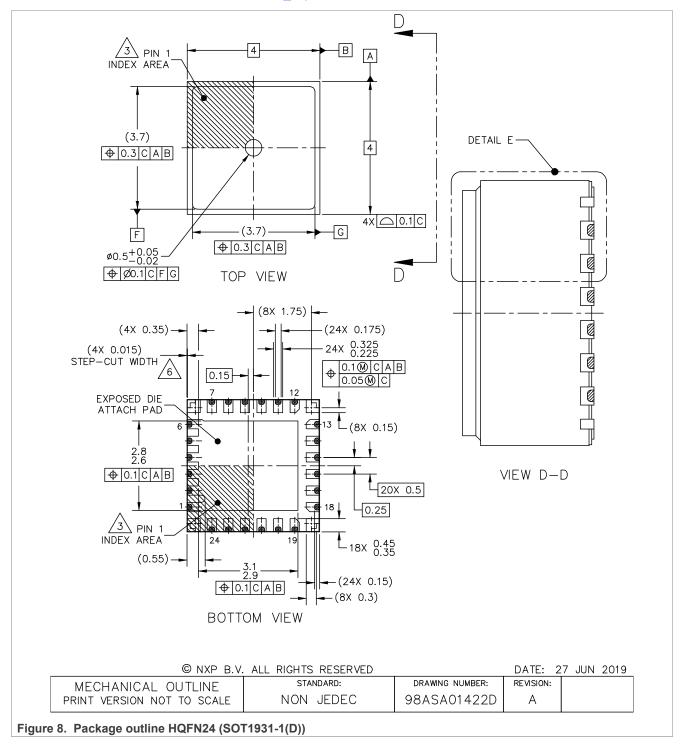
The package should be mounted with the pressure port pointing away from the axis of tire rotation. By mounting the pressure port away from the axis of tire rotation, centrifugal force propels any contaminants out of the pressure port. In cases where the application must orient the pressure port pointing inward, care must be taken to assure contaminants do not reach inside the pressure port.

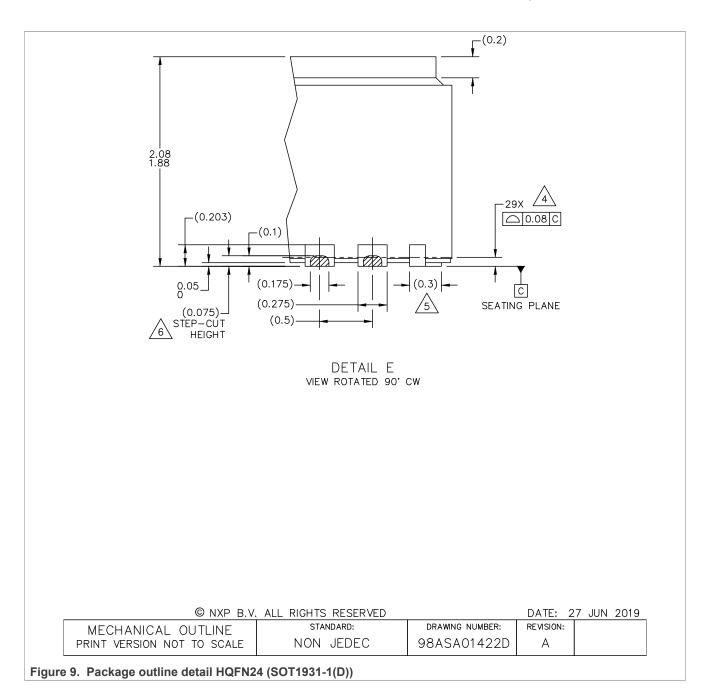
A plugged port exhibits no change in pressure and can be cross checked in the user software. Use the method described in user manual UM11227. [1]

Refer to application note AN1902<sup>[3]</sup> for proper printed circuit board attributes and recommendations.

# 9 Package outline

Consult the most recently issued drawing before initiating or completing a design. The drawings are available for download at <a href="https://www.nxp.com/docs/en/package-information/SOT1931-1\_D.pdf">https://www.nxp.com/docs/en/package-information/SOT1931-1\_D.pdf</a>.





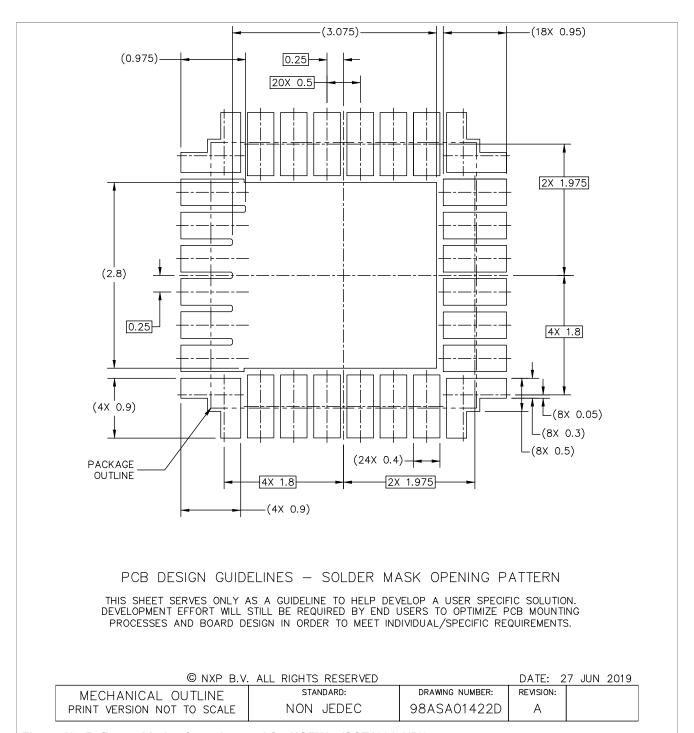


Figure 10. Reflow soldering footprint part1 for HQFN24 (SOT1931-1(D))

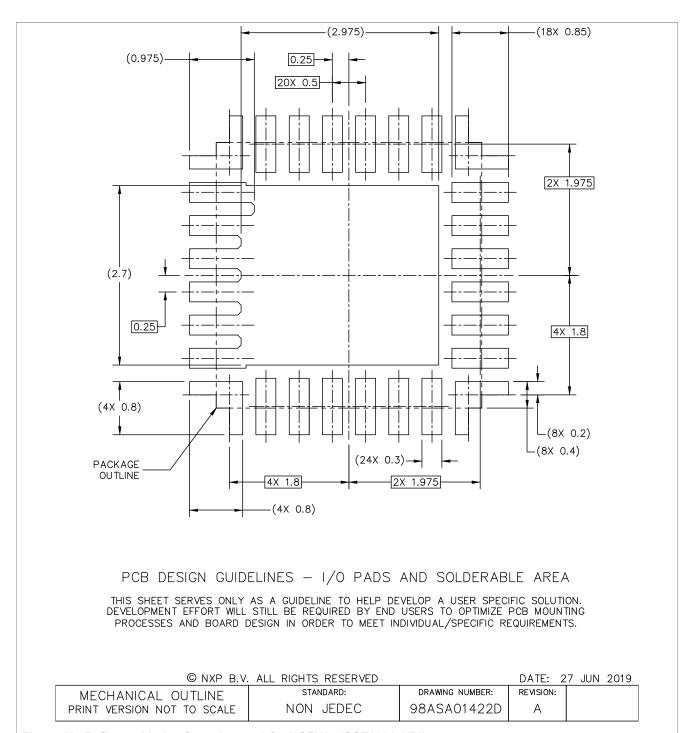
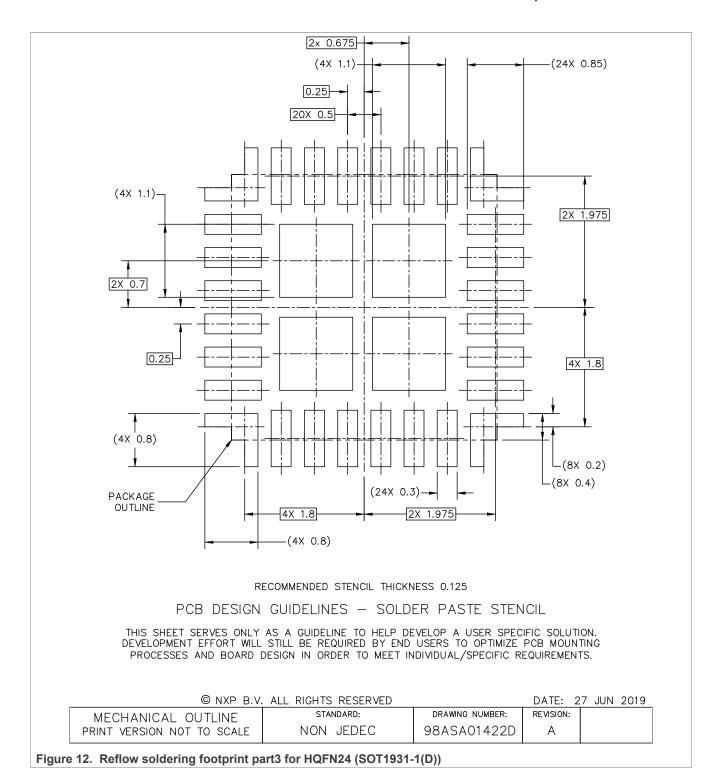


Figure 11. Reflow soldering footprint part2 for HQFN24 (SOT1931-1(D))



NTM88Hxx5S

#### NOTES:

- 1. ALL DIMENSIONS ARE IN MILLIMETERS.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

3 PIN 1 FEATURE SHAPE, SIZE AND LOCATION MAY VARY.

 $\sqrt{4}$  coplanarity applies to leads, die attach flag and corner non-functional pads.

5. ANCHORING PADS.

STEP-CUT IS APPLIED FOR BURR REMOVAL ONLY.

© NXP B.V. ALL RIGHTS RESERVED

MECHANICAL OUTLINE STANDARD: DRAWING NUMBER: REVISION: PRINT VERSION NOT TO SCALE NON JEDEC 98ASAO1422D A

Figure 13. Package outline notes HQFN24 (SOT1931-1(D))

### 10 References

#### **NXP** reference documents

- [1] UM11227, NTM88 family of tire pressure monitor sensors
- [2] NXP Specification NXPOMS-999116894-4501, Media test for TPMS MCM automotive pressure sensors
- [3] AN1902, Assembly guidelines for QFN (quad flat no-lead) and SON (small outline no-lead) packages

NTM88Hxx5S

All information provided in this document is subject to legal disclaimers.

NTM88Hxx5S

Tire pressure monitor sensor

# 11 Revision history

### Table 24. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
NTM88Hxx5S v.1	20221012	Objective data sheet	_	NTM88xxx5S v.1.2		
Modifications:	Initial release. This document supersedes NTM88xxx5S for the relevant part numbers in Section 3, Table 2 "Ordering options".					

# 12 Legal information

#### 12.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="https://www.nxp.com">https://www.nxp.com</a>.

#### 12.2 Definitions

**Draft** — A draft status on a document indicates that the content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included in a draft version of a document and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

#### 12.3 Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

**Applications** — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

NTM88Hxx5S

All information provided in this document is subject to legal disclaimers.

Suitability for use in automotive applications — This NXP product has been qualified for use in automotive applications. If this product is used by customer in the development of, or for incorporation into, products or services (a) used in safety critical applications or (b) in which failure could lead to death, personal injury, or severe physical or environmental damage (such products and services hereinafter referred to as "Critical Applications"), then customer makes the ultimate design decisions regarding its products and is solely responsible for compliance with all legal, regulatory, safety, and security related requirements concerning its products, regardless of any information or support that may be provided by NXP. As such, customer assumes all risk related to use of any products in Critical Applications and NXP and its suppliers shall not be liable for any such use by customer. Accordingly, customer will indemnify and hold NXP harmless from any claims, liabilities, damages and associated costs and expenses (including attorneys' fees) that NXP may incur related to customer's incorporation of any product in a Critical Application.

**Export control** — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

**Translations** — A non-English (translated) version of a document, including the legal information in that document, is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

Security — Customer understands that all NXP products may be subject to unidentified vulnerabilities or may support established security standards or specifications with known limitations. Customer is responsible for the design and operation of its applications and products throughout their lifecycles to reduce the effect of these vulnerabilities on customer's applications and products. Customer's responsibility also extends to other open and/or proprietary technologies supported by NXP products for use in customer's applications. NXP accepts no liability for any vulnerability. Customer should regularly check security updates from NXP and follow up appropriately. Customer shall select products with security features that best meet rules, regulations, and standards of the intended application and make the ultimate design decisions regarding its products and is solely responsible for compliance with all legal, regulatory, and security related requirements concerning its products, regardless of any information or support that may be provided by NXP.

NXP has a Product Security Incident Response Team (PSIRT) (reachable at <a href="PSIRT@nxp.com">PSIRT@nxp.com</a>) that manages the investigation, reporting, and solution release to security vulnerabilities of NXP products.

#### 12.4 Trademarks

Notice: All referenced brands, product names, service names, and trademarks are the property of their respective owners.

NXP — wordmark and logo are trademarks of NXP B.V.

# NTM88Hxx5S

# Tire pressure monitor sensor

# **Tables**

	dering information	2	Tab. 15.	Pressure measurement characteristics (90	
Tab. 2. Or	dering options	2		kPa to 930 kPa) range	.14
Tab. 3. Pir	n description	4	Tab. 16.	Acceleration measurement characteristic (-	
Tab. 4. Ele	ectrical and mechanical specification			80 g to +90 g) range option	. 15
no	te definition table	7	Tab. 17.	Acceleration measurement characteristic (-	
Tab. 5. Ma	aximum ratings	8		360 g to +400 g) range option	16
	perating range		Tab. 18.	Acceleration measurement characteristic (-	
	narge consumptions			120 g to +520 g) range option	. 17
	ocks and thresholds		Tab. 19.	Acceleration measurement characteristic (-	
Tab. 9. Po	ower-on reset	11		175 g to +550 g) range option	. 18
Tab. 10. GF	PIO port pins	11	Tab. 20.	Acceleration measurement characteristic (–	
	PI timing			400 g to +400 g) range option	. 20
	mperature measurement		Tab. 21.	LFR characteristics	
	oltage measurement characteristics		Tab. 22.	Radio frequency transmitter characteristics	
	cternal pin voltage measurement		Tab. 23.	Maximum ratings	
			Tab. 24.	Revision history	
Figures					
Fig. 1. Blo	ock diagram	3	Fig. 9.	Package outline detail HQFN24	
	ock diagram		Fig. 9.		29
Fig. 2. Pir	ock diagramn configuration	4	Ü	(SOT1931-1(D))	29
Fig. 2. Pir Fig. 3. NT	n configuration FM88Hxx5S orientation at rest	4 7	Fig. 9.	(SOT1931-1(D))Reflow soldering footprint part1 for	
Fig. 2. Pir Fig. 3. NT Fig. 4. Dy	n configuration	4 7 25	Ü	(SOT1931-1(D)) Reflow soldering footprint part1 for HQFN24 (SOT1931-1(D))	
Fig. 2. Pir Fig. 3. NT Fig. 4. Dy Fig. 5. Dy	n configuration FM88Hxx5S orientation at rest rnamic power adjustment — 315 MHz .	4 7 25	Fig. 10.	(SOT1931-1(D))	. 30
Fig. 2. Pir Fig. 3. NT Fig. 4. Dy Fig. 5. Dy Fig. 6. RF	n configuration	4 7 25 25	Fig. 10.	(SOT1931-1(D)) Reflow soldering footprint part1 for HQFN24 (SOT1931-1(D))	. 30
Fig. 2. Pir Fig. 3. NT Fig. 4. Dy Fig. 5. Dy Fig. 6. RF	n configuration	4 7 25 25	Fig. 10.	(SOT1931-1(D))  Reflow soldering footprint part1 for HQFN24 (SOT1931-1(D))  Reflow soldering footprint part2 for HQFN24 (SOT1931-1(D))  Reflow soldering footprint part3 for	. 30 . 31
Fig. 2. Pir Fig. 3. NT Fig. 4. Dy Fig. 5. Dy Fig. 6. RF col Fig. 7. Ba	n configuration	4 7 25 25 25	Fig. 10.	(SOT1931-1(D))	. 30 . 31

# **Contents**

1	General description	
2	Features and benefits	
3	Ordering information	
4	Block diagram	3
5	Pinning information	4
5.1	Pinning	4
5.2	Pin description	4
5.3	Orientation	
6	Electrical specifications	
6.1	Maximum ratings (electrical)	
6.2	Operating conditions	8
6.3	Charge consumptions	10
6.4	Clocks and thresholds	
6.5	Power-on reset operation	
6.6	GPIO port pins	
6.7	SPI timing characteristics	
6.8	Temperature measurement characteristics	
6.9	Voltage measurement characteristics	
6.10	Pressure measurement characteristics	14
6.10.1	Pressure measurement characteristic	
	(90 kPa to 930 kPa) range	14
6.11	Acceleration measurement characteristics	15
6.11.1	Acceleration measurement characteristics	
	(-80 g to +90 g) range option	15
6.11.2	Acceleration measurement characteristic (-	
	360 g to +400 g) range option	16
6.11.3	Acceleration measurement characteristic (-	
	120 g to +520 g) range option	17
6.11.4	Acceleration measurement characteristic (-	
	175 g to +550 g) range option	18
6.11.5	Acceleration measurement characteristic (-	
	400 g to +400 g) range option	
6.12	Low frequency receiver characteristics	
6.13	Radio frequency transmitter characteristics	
6.14	Power consumption RF transmissions	
7	Mechanical specifications	
7.1	Maximum ratings (mechanical)	
7.2	Media compatibility	
8	Mounting recommendations	
9	Package outline	
10	References	
11	Revision history	
12	Legal information	35

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.